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## 4 Revision History

注：以前版本的页码可能与当前版本的页码不同

| Changes from Revision * (April 2018) to Revision A (May 2022)               | Page |
|-----------------------------------------------------------------------------|------|
| • 更新了整个文档中的表格、图和交叉参考的编号格式.....                                              | 1    |
| • 将提到 SPI 的旧术语的所有实例更改为控制器和外设.....                                           | 1    |
| • Changed operating free-air temperature minimum from: –25°C to: –40°C..... | 4    |

## 5 Pin Configuration and Functions

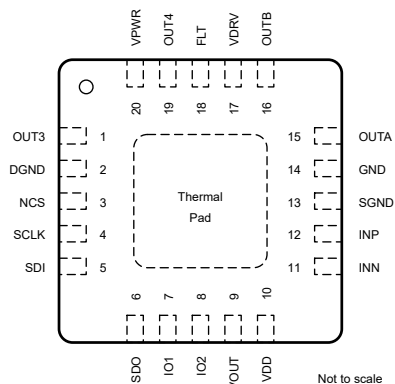


**图 5-1. RTJ Package 20-Pin WQFN With Exposed Thermal Pad (Top View)**

| PIN |      | TYPE <sup>(1)</sup> | DESCRIPTION                    |
|-----|------|---------------------|--------------------------------|
| NO. | NAME |                     |                                |
| 1   | OUT3 | O                   | General-purpose digital output |
| 2   | DGND | G                   | Digital ground                 |
| 3   | NCS  | I                   | SPI negative chip select       |
| 4   | SCLK | I                   | SPI CLK                        |
| 5   | SDI  | I                   | SPI data input                 |
| 6   | SDO  | O                   | SPI data output                |
| 7   | IO1  | I                   | General-purpose digital input  |
| 8   | IO2  | I                   | General-purpose digital input  |
| 9   | VOUT | O                   | Demodulated echo analog output |
| 10  | VDD  | P                   | Voltage regulator input        |
| 11  | INN  | I                   | Negative transducer receive    |
| 12  | INP  | I                   | Positive transducer receive    |
| 13  | SGND | G                   | Sensor ground (quiet)          |
| 14  | GND  | G                   | Ground                         |
| 15  | OUTA | O                   | Transducer driver output A     |
| 16  | OUTB | O                   | Transducer driver output B     |
| 17  | VDRV | P                   | H-bridge driver supply voltage |
| 18  | FLT  | I/O                 | Filter components              |
| 19  | OUT4 | O                   | General-purpose digital output |
| 20  | VPWR | P                   | Input supply voltage           |

(1) I = input, O = output, I/O = input and output, G = ground, P = power

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                      |                                       | MIN  | MAX                     | UNIT |
|----------------------|---------------------------------------|------|-------------------------|------|
| V <sub>VPWR</sub>    | Supply voltage range                  | −0.3 | 40                      | V    |
| V <sub>VDD</sub>     | Voltage regulator input voltage       | −0.3 | 5.5                     | V    |
| V <sub>VDRV</sub>    | H-bridge drive voltage                | −0.3 | V <sub>VPWR</sub> + 0.3 | V    |
| V <sub>FLT</sub>     | Filter component pin                  | −0.3 | V <sub>VDD</sub> + 0.3  | V    |
| V <sub>INX</sub>     | INP, INN pins input voltage           | 0.5  | 1.3                     | V    |
| V <sub>DIG_IN</sub>  | SCLK, SDI, NCS, IOx pin input voltage | −0.3 | V <sub>VDD</sub> + 0.3  | V    |
| V <sub>VOU</sub>     | Analog output voltage                 | −0.3 | V <sub>VDD</sub> + 0.3  | V    |
| V <sub>DIG_OUT</sub> | SDO, OUTx, IOx pin output voltage     | −0.3 | V <sub>VDD</sub> + 0.3  | V    |
| V <sub>OUTA_B</sub>  | OUTA, OUTB pins output voltage        | −0.3 | V <sub>VDRV</sub> + 0.3 | V    |
| T <sub>A</sub>       | Ambient temperature                   | −40  | 105                     | °C   |
| T <sub>J</sub>       | Junction temperature                  | −40  | 125                     |      |
| T <sub>stg</sub>     | Storage temperature                   | −40  | 125                     |      |

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 6.2 ESD Ratings

|                    |                         |                                                                                          | VALUE | UNIT |
|--------------------|-------------------------|------------------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>              | ±2000 | V    |
|                    |                         | Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup> | ±500  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                         |                                                                                                                     | MIN  | NOM  | MAX              | UNIT |
|-------------------------|---------------------------------------------------------------------------------------------------------------------|------|------|------------------|------|
| V <sub>VPWR</sub>       | Supply voltage on VPWR pin                                                                                          | 5    |      | 36               | V    |
| V <sub>VDRV</sub>       | Voltage on VDRV pin, internal regulation on VDRV disabled (VDRV_HI_Z=1) <sup>(1)</sup>                              | 5    |      | 36               | V    |
|                         | VDRV voltage Pre driver mode (PRE_DRIVER_MODE=1), internal regulation on VDRV disabled (VDRV_HI_Z=1) <sup>(1)</sup> | 5    |      | 15               | V    |
| V <sub>DIG_IO</sub>     | Digital I/O pins                                                                                                    | −0.1 |      | V <sub>VDD</sub> | V    |
| V <sub>VDD</sub>        | Regulated voltage Input                                                                                             | 3.1  |      | 5.5              | V    |
| I <sub>VPWR_INDIR</sub> | Current consumption at VPWR pin during ranging                                                                      | 150  | 240  | 340              | μA   |
| I <sub>VPWR_STDBY</sub> | Current consumption at VPWR in standby mode                                                                         | 150  | 220  | 340              | μA   |
| I <sub>VDD_INDIR</sub>  | Current consumption at VDD pin during ranging                                                                       | 7    | 11.5 | 13               | mA   |
| I <sub>VDD_STDBY</sub>  | Current consumption at VDD in standby mode                                                                          | 1.2  | 1.5  | 2.5              | mA   |
| I <sub>VDD_SLEEP</sub>  | Current consumption in sleep mode                                                                                   |      |      | 350              | μA   |
| T <sub>A</sub>          | Operating free-air temperature                                                                                      | −40  |      | 105              | °C   |
| T <sub>J</sub>          | Operating junction temperature                                                                                      | −40  |      | 125              | °C   |

- (1) Always V<sub>VPWR</sub> > V<sub>VDRV</sub> + 0.3 V to prevent reverse current from VDRV pin to VPWR pin

## 6.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | TUSS4470   | UNIT |
|-------------------------------|----------------------------------------------|------------|------|
|                               |                                              | RTJ (WQFN) |      |
|                               |                                              | 20 PINS    |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 36.3       | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 29.4       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 14.7       | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 0.4        | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 14.7       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 4.7        | °C/W |

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.5 Power-Up Characteristics

over operating free-air temperature range, V<sub>VPWR</sub>, V<sub>VDRV</sub> and V<sub>VDD</sub> recommended voltage range (unless otherwise noted)

| PARAMETER           |                                                     | TEST CONDITIONS                                                          | MIN   | TYP | MAX   | UNIT |
|---------------------|-----------------------------------------------------|--------------------------------------------------------------------------|-------|-----|-------|------|
| t <sub>PWR_ON</sub> | Time to power up when SPI communication is possible |                                                                          |       |     | 10    | ms   |
| V <sub>VDRV</sub>   | Regulated voltage on VDRV pin <sup>(1)</sup>        | VDRV_VOLTAGE_LEVEL = 0x0; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 4.5   | 5   | 5.3   | V    |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0x4; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 8.1   | 9   | 9.9   |      |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0x7; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 11.5  | 12  | 12.6  |      |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0x8; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 12.09 | 13  | 13.91 |      |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0xC; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 15.81 | 17  | 18.9  |      |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0xD; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 16.74 | 18  | 19.26 |      |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0xE; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 17.67 | 19  | 20.33 |      |
|                     |                                                     | VDRV_VOLTAGE_LEVEL = 0xF; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 100 mV | 19.0  | 20  | 21.4  |      |
| I <sub>VDRV</sub>   | VDRV capacitor charging current                     | VDRV_CURRENT_LEVEL = 0x0; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 1 V    | 8.5   | 10  | 11.5  | mA   |
|                     |                                                     | VDRV_CURRENT_LEVEL = 0x1; V <sub>VPWR</sub> > V <sub>VDRV</sub> + 1 V    | 17    | 20  | 23    |      |

(1) Other VDRV voltage levels possible.

## 6.6 Transducer Drive

over operating free-air temperature range, V<sub>VPWR</sub>, V<sub>VDRV</sub> and V<sub>VDD</sub> recommended voltage range (unless otherwise noted)

| PARAMETER           |                                | TEST CONDITIONS         | MIN | TYP | MAX | UNIT |
|---------------------|--------------------------------|-------------------------|-----|-----|-----|------|
| R <sub>HS_FET</sub> | High-side MOSFET on-resistance | T <sub>A</sub> = +105°C |     |     | 30  | Ω    |
| R <sub>LS_FET</sub> | Low-side MOSFET on-resistance  | T <sub>A</sub> = +105°C |     |     | 20  | Ω    |

## 6.7 Receiver Characteristics

over operating free-air temperature range,  $V_{VPWR}$ ,  $V_{VDRV}$  and  $V_{VDD}$  recommended voltage range (unless otherwise noted)

| PARAMETER       |                                                                           | TEST CONDITIONS                                                                                                     | MIN  | TYP  | MAX   | UNIT          |
|-----------------|---------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------|------|------|-------|---------------|
| $G_{LNA}$       | Low-noise amplifier fixed gain                                            | LNA_GAIN = 0x00; $f_{DRV\_CLK}$ = 58 KHz                                                                            | 13.7 | 15   | 16.8  | V/V           |
| $G_{LNA}$       |                                                                           | LNA_GAIN = 0x01; $f_{DRV\_CLK}$ = 58 KHz                                                                            | 9.4  | 10   | 12    |               |
| $G_{LNA}$       |                                                                           | LNA_GAIN = 0x10; $f_{DRV\_CLK}$ = 58 KHz                                                                            | 17.6 | 20   | 21.8  |               |
| $G_{LNA}$       |                                                                           | LNA_GAIN = 0x11; $f_{DRV\_CLK}$ = 58 KHz                                                                            | 11.6 | 12.5 | 14.2  |               |
| $DR_{VIN\_MIN}$ | Minimum receive input <sup>(2)</sup>                                      | LOGAMP_DIS_FIRST=0x0; LOGAMP_DIS_LAST=0x0<br>LNA_GAIN=0x00; $ERR_{LOG} < \pm 3dB$ ; $f_{DRV\_CLK} < 500KHz$         |      | 2.4  |       | $\mu V_{rms}$ |
| $DR_{VIN\_MAX}$ | Maximum receive input <sup>(2)</sup>                                      |                                                                                                                     |      | 48   |       | mVrms         |
| $SL_{AFE}$      | Slope of analog front end <sup>(4)</sup>                                  | VOUT_SCALE_SEL = 0x0; $f_{DRV\_CLK}$ = 58 KHz                                                                       | 25   | 29.7 | 33    | mV/dB         |
|                 |                                                                           | VOUT_SCALE_SEL = 0x1; $f_{DRV\_CLK}$ = 58 KHz                                                                       | 38   | 45.1 | 46    |               |
| $DR_{AFE}$      | Receiver path dynamic range (minimum to maximum input) <sup>(2)</sup>     | LOGAMP_DIS_FIRST = 0x0; LOGAMP_DIS_LAST = 0x0<br>$ERR_{LOG} < \pm 3 dB$ ; $f_{DRV\_CLK} < 500 KHz$                  | 82   |      | 92    | dB            |
|                 |                                                                           | LOGAMP_DIS_FIRST = 0x0; LOGAMP_DIS_LAST = 0x1<br>$ERR_{LOG} < \pm 3 dB$ ; $f_{DRV\_CLK} < 500 KHz$                  | 74   |      | 86    |               |
|                 |                                                                           | LOGAMP_DIS_FIRST = 0x1; LOGAMP_DIS_LAST=0x1<br>$ERR_{LOG} < \pm 3dB$ ; $f_{DRV\_CLK} < 500 KHz$                     | 59   |      | 70    |               |
|                 | Receiver path dynamic Range (noise floor to maximum input) <sup>(3)</sup> | LOGAMP_DIS_FIRST = 0x0; LOGAMP_DIS_LAST = 0x0<br>$ERR_{LOG} < \pm 3 dB$ ; $f_{DRV\_CLK} < 500 KHz$                  | 74   |      | 84    |               |
| $BW_{LOG}$      | Logamp bandwidth                                                          | Information only                                                                                                    | 40   |      | 1000  | KHz           |
| $INT_{LOG}$     | Intercept point in dBV                                                    | LOGAMP_DIS_FIRST=0x0; LOGAMP_DIS_LAST=0x0;<br>$f_{DRV\_CLK}$ = 40 KHz                                               | -108 |      | -97   | dBV           |
|                 |                                                                           | LOGAMP_DIS_FIRST = 0x0; LOGAMP_DIS_LAST=0x1;<br>$f_{DRV\_CLK}$ = 40 KHz                                             | -94  |      | -86   |               |
|                 |                                                                           | LOGAMP_DIS_FIRST = 0x1; LOGAMP_DIS_LAST=0x1;<br>$f_{DRV\_CLK}$ = 40 KHz                                             | -80  |      | -70   |               |
| $ERR_{LOG}$     | Log conformance error                                                     | Information only                                                                                                    | -3   |      | 3     | dB            |
| $f_{BPF}$       | Configurable range of center frequency of BPF                             | BPF_BYPASS = 0x0; BPF_FC_TRIM = 0x0;<br>set by different values of BPF_HPF_FREQ                                     | 40   |      | 500   | KHz           |
| $Q_{BPF}$       | Q of bandpass filter                                                      | BPF_BYPASS = 0x0; BPF_Q_SEL = 0x0 <sup>(1)</sup>                                                                    | 3    | 4    | 5.2   |               |
| $R_{LPF}$       | Internal resistor on FLT pin to ground                                    |                                                                                                                     |      | 6.25 |       | K $\Omega$    |
| $V_{O\_PDSTL}$  | Output pedestal level <sup>(2)</sup>                                      | $V_{VDD} = 3.3 V$ ; $f_{DRV\_CLK} = 40 KHz$ ; VOUT_SCALE_SEL = 0x0<br>LOGAMP_DIS_FIRST = 0x0; LOGAMP_DIS_LAST = 0x0 | 0.3  |      | 0.45  | V             |
|                 |                                                                           | $V_{VDD} = 5.0 V$ ; $f_{DRV\_CLK} = 40 KHz$ ; VOUT_SCALE_SEL = 0x1<br>LOGAMP_DIS_FIRST = 0x0; LOGAMP_DIS_LAST = 0x0 | 0.45 |      | 0.675 |               |

over operating free-air temperature range,  $V_{VPWR}$ ,  $V_{VDRV}$  and  $V_{VDD}$  recommended voltage range (unless otherwise noted)

| PARAMETER       | TEST CONDITIONS                                                                                                                                                            | MIN | TYP | MAX | UNIT |
|-----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|------|
| $V_{N\_pk\_pk}$ | $V_{VDD}=3.3\text{ V}$ ; $f_{DRV\_CLK} = 40\text{ KHz}$ ; $C_{FLT} = 15\text{ nF}$ ; $V_{OUT\_SCALE\_SEL} = 0x0$<br>$LOGAMP\_DIS\_FIRST = 0x0$ ; $LOGAMP\_DIS\_LAST=0x0$   | 50  |     | 200 | mVpp |
|                 | $V_{VDD}=5.0\text{ V}$ ; $f_{DRV\_CLK} = 40\text{ KHz}$ ; $C_{FLT} = 15\text{ nF}$ ; $V_{OUT\_SCALE\_SEL} = 0x1$<br>$LOGAMP\_DIS\_FIRST = 0x0$ ; $LOGAMP\_DIS\_LAST = 0x0$ | 75  |     | 300 |      |

- (1) Other choices of Q possible.
- (2) Measured with effectively very large  $C_{FLT}$ . Actual minimum signal detectable will depend on  $V_{N\_pk\_pk}$ . Minimum and maximum input levels are defined by  $ERR_{LOG}$ .
- (3) Measured with different  $C_{FLT}$  values according to 方程式 3. Noise floor is set by  $V_{N\_PK\_PK}$  in addition to  $V_{O\_PDSTL}$ .
- (4) Slope measured with factory trim at  $f_{DRV\_CLK} = 58\text{ KHz}$ . Slope can be adjusted with  $LOGAMP\_SLOPE\_ADJ$  bits for different  $f_{DRV\_CLK}$  settings.

## 6.8 Echo Interrupt Comparator Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER                |                                                    | TEST CONDITIONS        | MIN  | TYP | MAX  | UNIT |
|--------------------------|----------------------------------------------------|------------------------|------|-----|------|------|
| VOUT_SCALE_SEL = 0x0     |                                                    |                        |      |     |      |      |
| V <sub>ECMP_THR_0</sub>  | Echo interrupt comparator threshold <sup>(1)</sup> | ECHO_INT_THR_SEL = 0x0 | 0.37 | 0.4 | 0.43 | V    |
|                          |                                                    | ECHO_INT_THR_SEL = 0x5 | 0.56 | 0.6 | 0.64 |      |
|                          |                                                    | ECHO_INT_THR_SEL = 0xA | 0.75 | 0.8 | 0.85 |      |
|                          |                                                    | ECHO_INT_THR_SEL = 0xF | 0.94 | 1   | 1.06 |      |
| V <sub>ECMP_HYS_0</sub>  | Echo interrupt comparator hysteresis               |                        | 7    |     | 68   | mV   |
| VOUT_SCALE_SEL = 0x1     |                                                    |                        |      |     |      |      |
| V <sub>E_CMP_THR_1</sub> | Echo interrupt comparator threshold <sup>(1)</sup> | ECHO_INT_THR_SEL = 0x0 | 0.56 | 0.6 | 0.64 | V    |
|                          |                                                    | ECHO_INT_THR_SEL = 0x5 | 0.84 | 0.9 | 0.96 |      |
|                          |                                                    | ECHO_INT_THR_SEL = 0xA | 1.13 | 1.2 | 1.27 |      |
|                          |                                                    | ECHO_INT_THR_SEL = 0xF | 1.41 | 1.5 | 1.59 |      |
| V <sub>ECMP_HYS_1</sub>  | Echo interrupt output threshold level hysteresis   |                        | 7    |     | 68   | mV   |

- (1) Other thresholds possible.

## 6.9 Digital I/O Characteristics

over operating free-air temperature range,  $V_{VPWR}$ ,  $V_{VDRV}$  and  $V_{VDD}$  recommended voltage range (unless otherwise noted)

| PARAMETER              |                                          | TEST CONDITIONS                                 | MIN                    | TYP | MAX | UNIT             |
|------------------------|------------------------------------------|-------------------------------------------------|------------------------|-----|-----|------------------|
| V <sub>IH_DIGIO</sub>  | Digital input high-level                 | NCS, SDI, SCLK and IOx pins                     | 0.7                    |     |     | V <sub>VDD</sub> |
| V <sub>IL_DIGIO</sub>  | Digital input low-level                  |                                                 | 0.3                    |     |     | V <sub>VDD</sub> |
| V <sub>HYS_DIGIO</sub> | Digital input hysteresis                 |                                                 | 100                    |     |     | mV               |
| V <sub>OH_DIGIO</sub>  | Digital output high-level <sup>(1)</sup> | SDO, OUTx pins; I <sub>DIGIO_OUT</sub> = − 1 mA | V <sub>VDD</sub> − 0.1 |     |     | V                |
| V <sub>OL_DIGIO</sub>  | Digital output low-level <sup>(1)</sup>  | SDO, OUTx pins; I <sub>DIGIO_OUT</sub> = 1 mA   | 0.1                    |     |     | V                |
| V <sub>O_CAP</sub>     | Maximum output load capacitance          | SDO pin. Information Only                       | 10                     |     |     | pF               |
| R <sub>PU_DIGIO</sub>  | Digital input pullup resistance to VDD   | NCS, IO1, IO2 pins                              | 80                     | 100 | 130 | kΩ               |
| R <sub>PD_DIGIO</sub>  | Digital Input pulldown resistance to GND | SCLK, SDI pins                                  | 80                     | 100 | 130 | kΩ               |

- (1) No short-circuit protection on output pins. Damage may occur for currents higher than specified.

## 6.10 Switching Characteristics

over operating free-air temperature range,  $V_{VPWR}$ ,  $V_{VDRV}$  and  $V_{VDD}$  recommended voltage range (unless otherwise noted)

| PARAMETER      |                                                                           | TEST CONDITIONS                                                                   | MIN | TYP | MAX  | UNIT |
|----------------|---------------------------------------------------------------------------|-----------------------------------------------------------------------------------|-----|-----|------|------|
| $f_{DRV\_CLK}$ | Frequency of drive clock at IO1 and IO2 pin ; depends on the VDRV voltage | Used as burst frequency;<br>PRE_DRIVER_MODE = 0x0                                 | 40  |     | 1000 | KHz  |
|                | Frequency of drive clock at IO1 and IO2 pin                               | Used as burst frequency;<br>PRE_DRIVER_MODE = 0x1; Load cap<br>on OUTA/OUTB = 2nF | 40  |     | 440  | KHz  |
| $SPI_{RATE}$   | SPI bit rate                                                              |                                                                                   |     |     | 500  | KHz  |

## 6.11 Typical Characteristics

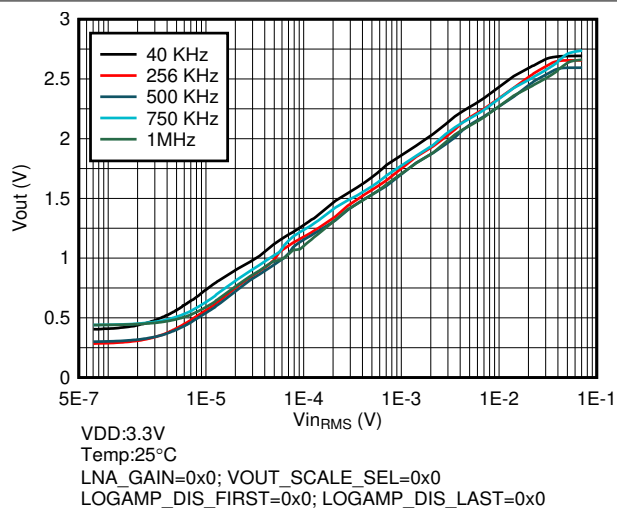


图 6-1. Receive Signal Path Transfer Function for VDD = 3.3 V

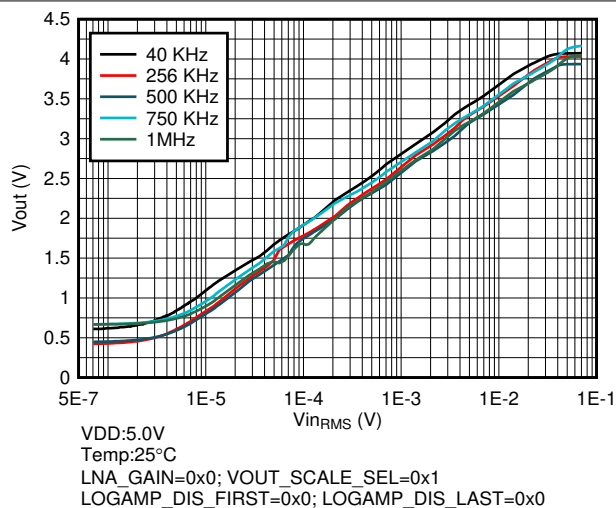


图 6-2. Receive Signal Path Transfer Function for VDD = 5 V

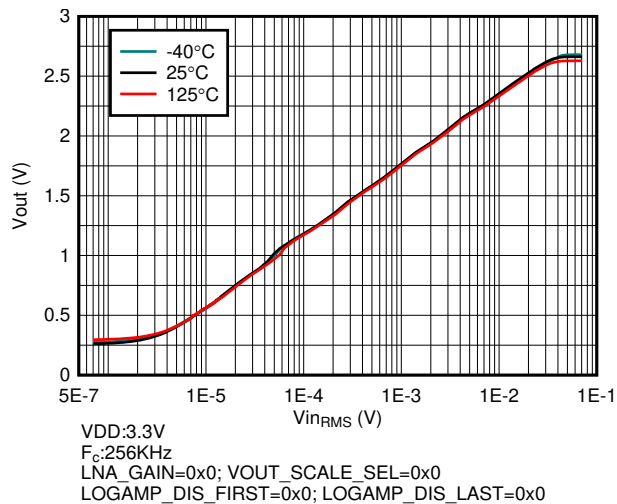


图 6-3. Receive Signal Path Transfer Function Across Temperature

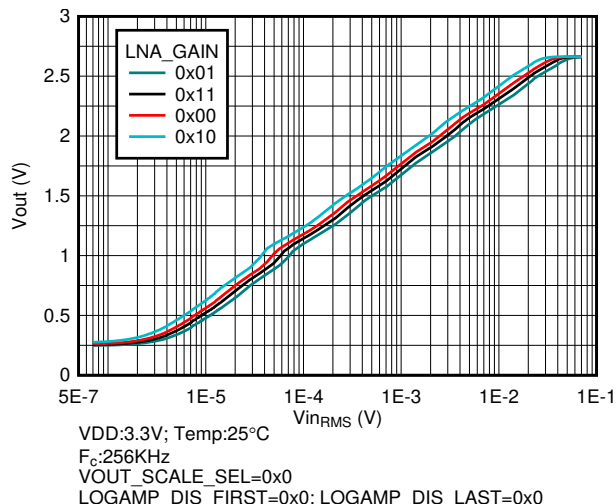


图 6-4. Receive Signal Path Transfer Function Across LNA Gain

## 6.11 Typical Characteristics (continued)

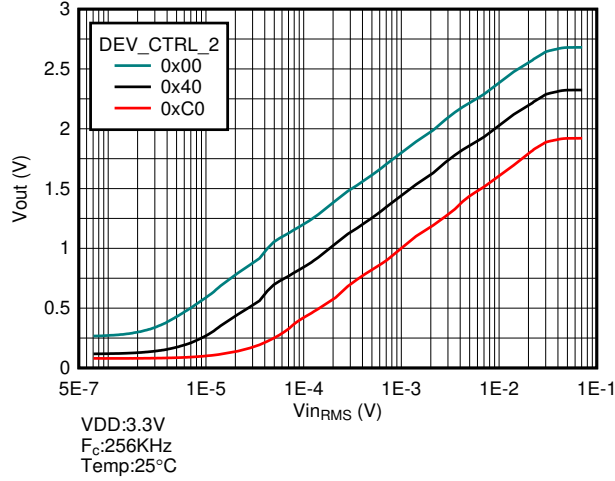


图 6-5. Receive Signal Path Transfer Function for Various Logamp Stages Disabled

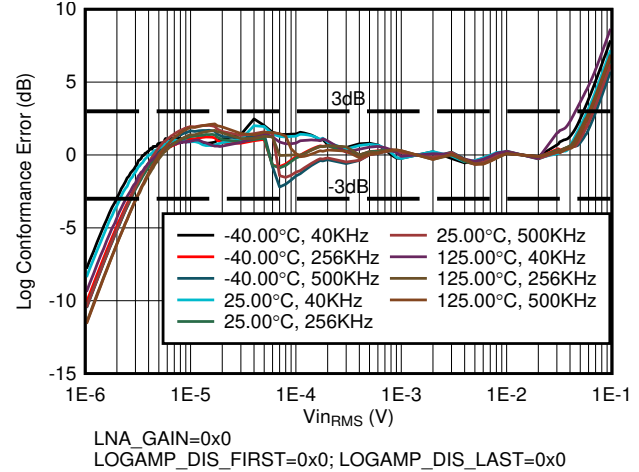


图 6-6. Receive Signal Path Log Conformance Error With All Stages Enabled

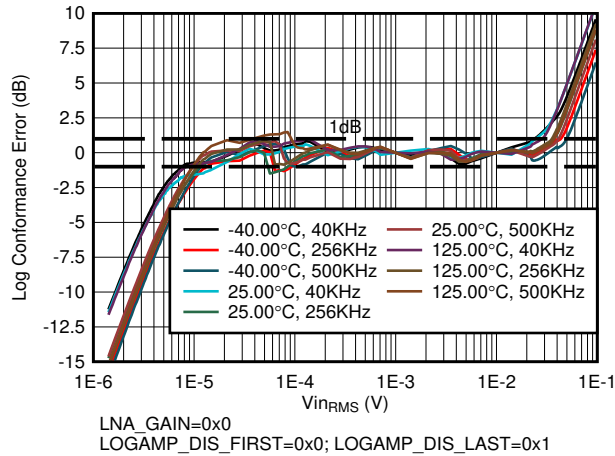


图 6-7. Receive Signal Path Log Conformance Error With Last Stage Disabled

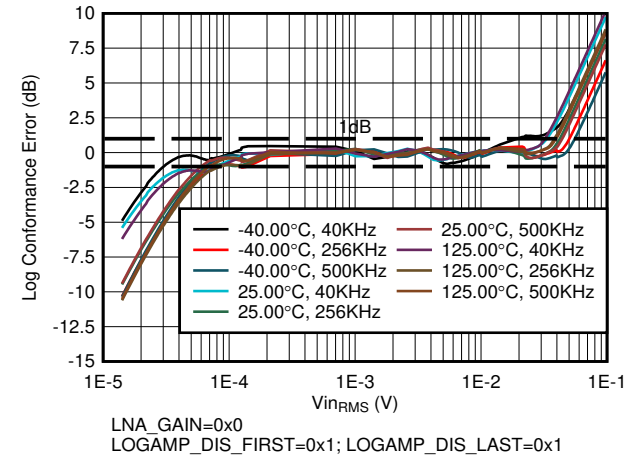


图 6-8. Receive Signal Path Log Conformance Error With First and Last Stage Disabled

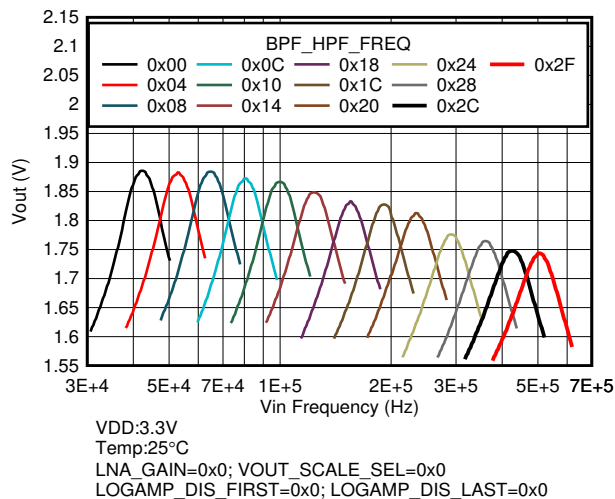


图 6-9. Receive Signal Path Bandpass Filter Transfer Function

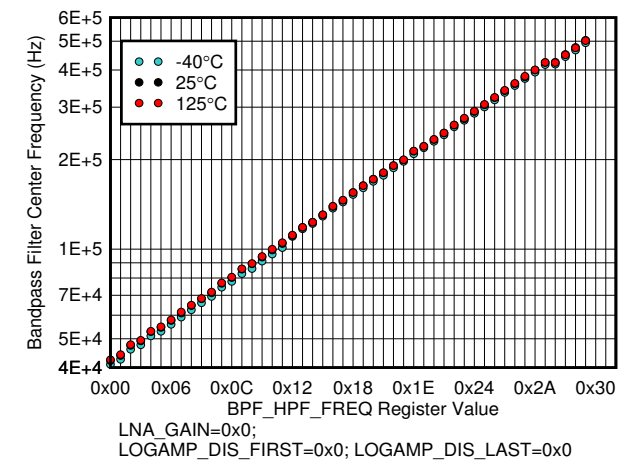


图 6-10. Receive Signal Path Bandpass Filter frequency for Various Register Settings

## 6.11 Typical Characteristics (continued)

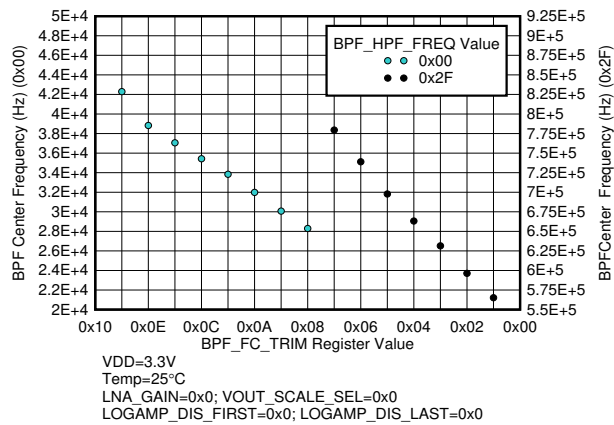


**图 6-11. Receive Signal Path Bandpass Filter Center Frequency Trim**

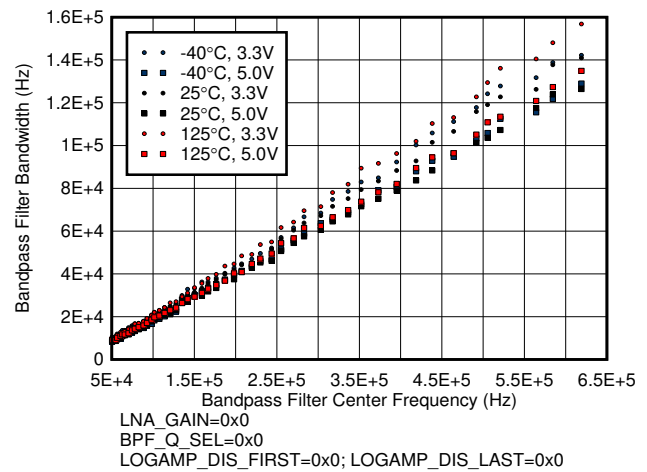


**图 6-12. Receive Signal Path Bandpass Filter Bandwidth for Various Center Frequency Settings**

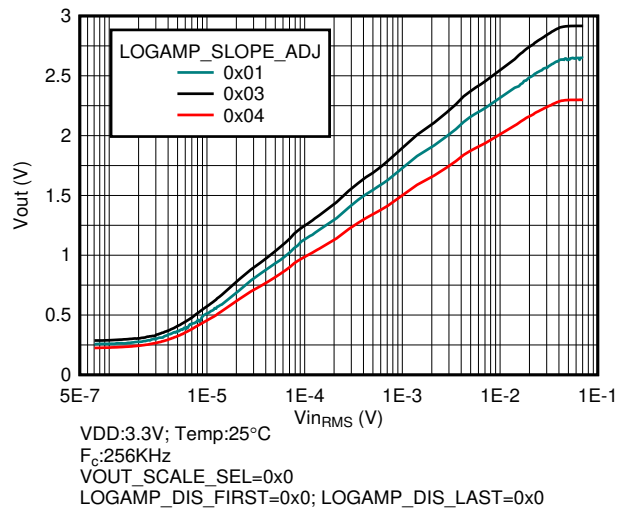


**图 6-13. Receive Signal Path Transfer Function for Various Slope Adjustments**

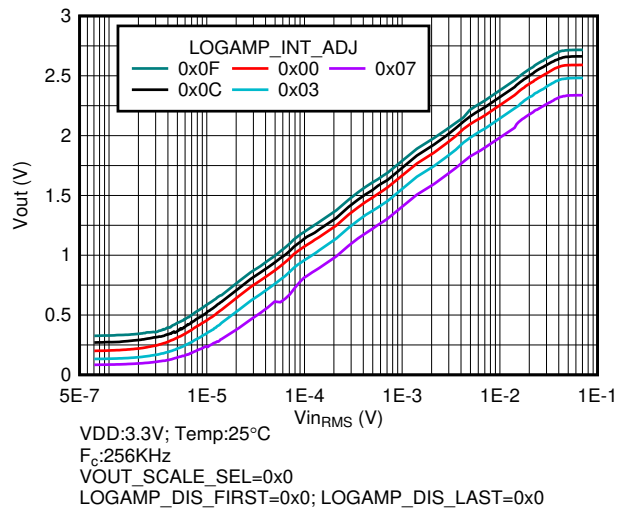


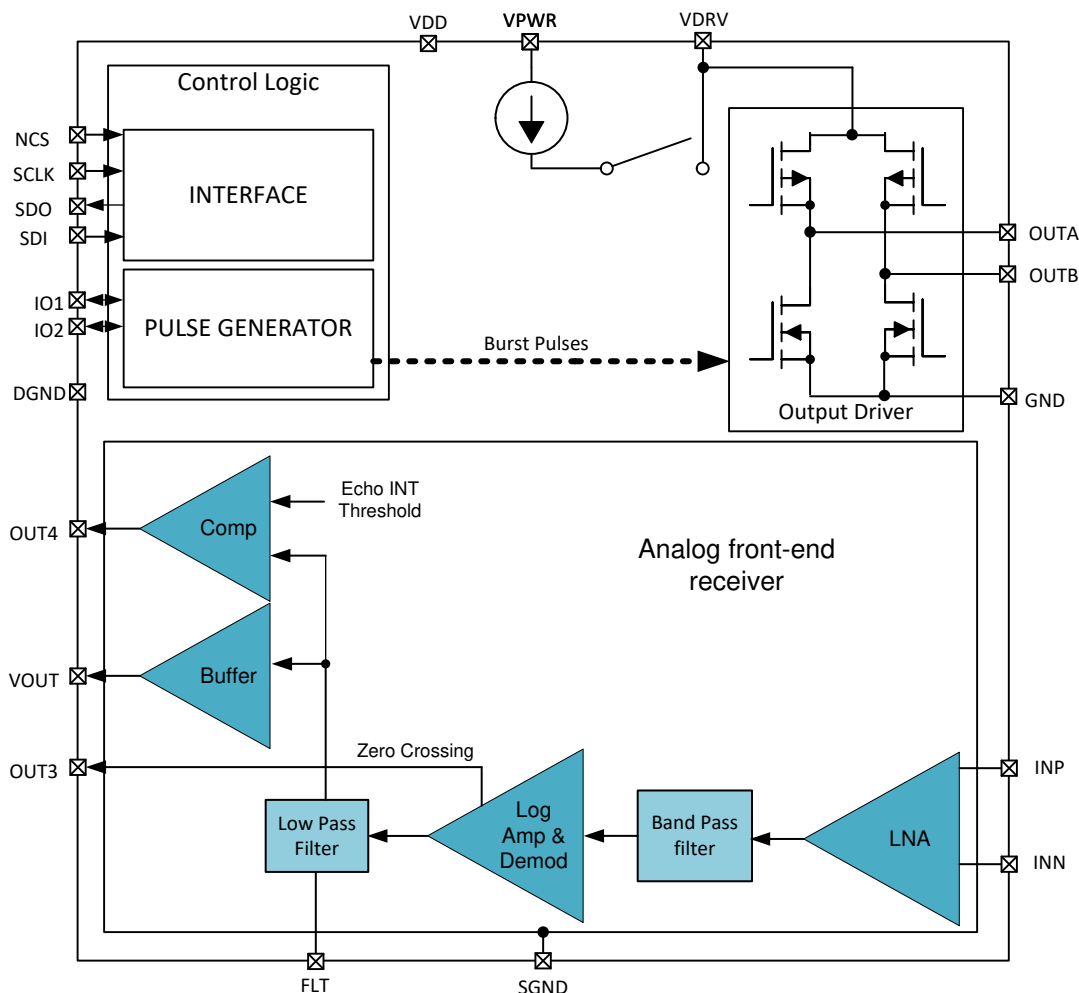
**图 6-14. Receive Signal Path Transfer Function for Various Intercept Adjustments**

## 7 Detailed Description

### 7.1 Overview

The TUSS4470 is a highly integrated driver and receiver IC designed especially for ultrasonic transducers operating between the range of 40 KHz to 1 MHz. The TUSS4470 integrates an H-bridge to drive the transducer directly. This is useful in applications where the receive transducer sensitivity is high and large driving voltage is not required to create sufficient sound pressure level and where short distance measurements are needed. The driver stage has flexible and configurable controls set through the SPI interface or through digital input pins that can be driven by an external MCU. The receive stage consists of a logarithmic amplifier receive chain. The logamp enables the TUSS4470 to have a wide dynamic input range. This enables applications where objects with different physical properties must be detected with the same sensor. A key advantage of the TUSS4470 is that it integrates a bandpass filter that can be tuned to the center frequency of the transducer. A demodulated analog output representing the receive echo, the zero crossing of the input signal, and a simple threshold crossing indicator enable a variety of end applications from complex object detection to simple presence detection.

### 7.2 Functional Block Diagram



### 7.3 Feature Description

#### 7.3.1 Excitation Power Supply (VDRV)

The TUSS4470 device includes a current source which charges a capacitor connected to the VDRV pin. The VDRV pin serves as the power supply for the integrated H-Bridge driver circuit. The voltage on the VDRV pin ( $V_{VDRV}$ ) is controlled by an internal voltage monitor which can be configured by the [VDRV\\_VOLTAGE\\_LEVEL](#).

bits. The current source is switched off after VDRV pin voltage crosses the configured  $V_{VDRV}$  value. The charging current ( $I_{VDRV}$ ) can be configured using [VDRV\\_CURRENT\\_LEVEL](#) bits.

In applications where VPWR can vary over a wide range, this allows the transducer drive voltage to be fixed for every burst for a deterministic sound pressure level created by the transducer. This is possible only when the minimum supply voltage on the VPWR pin is greater than the configured value of  $V_{VDRV}$ .

The VDRV regulation is disabled at device power up indicated by [VDRV\\_HI\\_Z](#) bit being set. To enable VDRV this bit must be cleared. This feature enables applications where the H-Bridge driver supply is connected to an external power supply source through the VDRV pin.

#### 备注

- When VDRV pin is supplied from an external power supply, it must be ensured that all times including during power up,  $V_{VPWR} > V_{VDRV} + 0.3\text{ V}$  to prevent any reverse current from VDRV pin to VPWR pin. Alternatively a reverse current prevention diode can be used on VPWR pin as shown in [图 8-1](#) (D1).
- Very fast ramp-up rate on VPWR pin should be avoided to prevent damage to the device. If fast ramp rates are possible, a series resistor between power supply and VPWR pin as shown in [图 8-1](#) ( $R_{PWR}$ ) is recommended.

After a burst is completed and during the long receive time (listen mode), the capacitor on VDRV pin will discharge causing the charging current to turn on intermittently. This can inject switching noise which can be picked by the analog front end as a spurious echo. To eliminate this noise, the [DIS\\_VDRV\\_REG\\_LSTN](#) bit can be set. This disables charging of VDRV automatically after the burst is done. The VDRV charging current can be turned on again by setting the [VDRV\\_TRIGGER](#) bit. Setting this bit may create a spurious echo which can be ignored by the echo processing in the MCU. The [VDRV\\_READY](#) bit in [DEV\\_STAT](#) register can be monitored to know when the required voltage level has been reached and the device is ready to generate a new burst. The [VDRV\\_TRIGGER](#) bit must be un-set through SPI just before the start of burst and will have to be set again for next charging cycle. If the [VDRV\\_TRIGGER](#) bit is not un-set before next burst cycle, the VDRV charging current will not be automatically disabled after the burst even when [DIS\\_VDRV\\_REG\\_LSTN](#) is set. This functionality is ignored when the [VDRV\\_HI\\_Z](#) bit is set.

### 7.3.2 Burst Generation

TUSS4470 has multiple modes to excite the transducer through OUTA and OUTB pins. For each of the modes, the desired frequency of burst is supplied through an external clock on the IOx pins. This enables the user to supply a highly precise clock calibrated to the center frequency of transducer to enable the highest sound pressure level generation. These modes can be selected by the [IO\\_MODE](#) bits in the [DEV\\_CTRL\\_3](#) register.

The burst mode is enabled first, then the start of burst (OUTA/OUTB changing states) happens at the next falling edge of IO1 or IO2, depending on the mode selected. These modes are described below.

- **IO\_MODE = 0:** In this mode, the external clock for the transducer is applied at the IO2 pin and the burst mode is enabled by setting the [CMD\\_TRIGGER](#) in the [TOF\\_CONFIG](#) register through SPI, as shown in [图 7-1](#). The device then expects a clock at IO2 pin to generate pulses on the OUTA/OUTB pins. The start of burst happens from the first falling edge of IO2. The number of pulses are counted by counting falling edge to next falling edge transitions on IO2 once the start of burst is triggered. The end of burst sequence is signaled when the number of pulses defined in [BURST\\_PULSE](#) are sent, or when the [CMD\\_TRIGGER](#) = 0 is set through SPI, whichever occurs earlier. TI recommends that IO2 is held high before burst enable to count the number of pulses correctly. After the start of burst, the state of OUTA and OUTB pins are determined by IO1 and IO2 pins. A transition of [CMD\\_TRIGGER](#) from high to low to high again is required to initiate a new burst sequence.

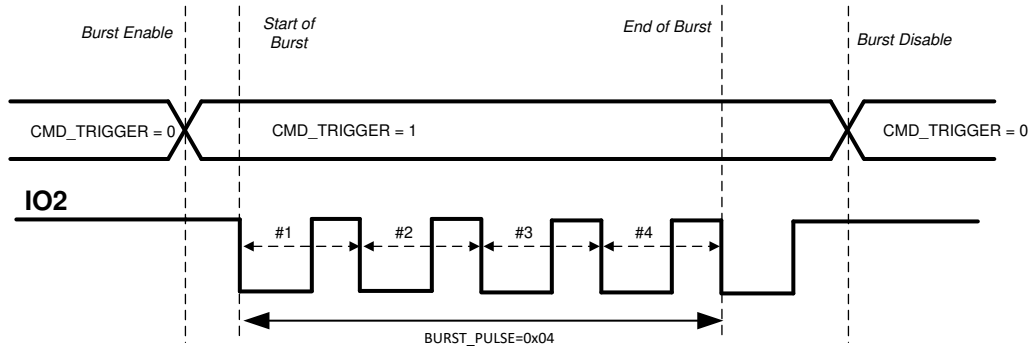


**图 7-1. IO\_MODE 0 Description**

- **IO\_MODE = 1:** In this mode, the external clock for the transducer is applied at the IO2 pin and the burst mode is enabled when IO1 pin transitions low (see 图 7-2). The device then expects a clock at IO2 pin to generate pulses on the OUTA/OUTB pins. The start of burst happens from the first falling edge of IO2. The number of pulses are counted by counting falling edge to next falling edge transitions on IO2 once the start of burst is triggered. End of burst sequence is signaled when the number of pulses defined in BURST\_PULSE are sent or IO1 transitions high, whichever occurs earlier. TI recommends that IO2 is held high before start of burst to count the number of pulse correctly. After the start of burst, the state of OUTA and OUTB pins are determined by IO1 and IO2 pins. A transition of IO1 from low to high to low again is required to initiate a new burst sequence.

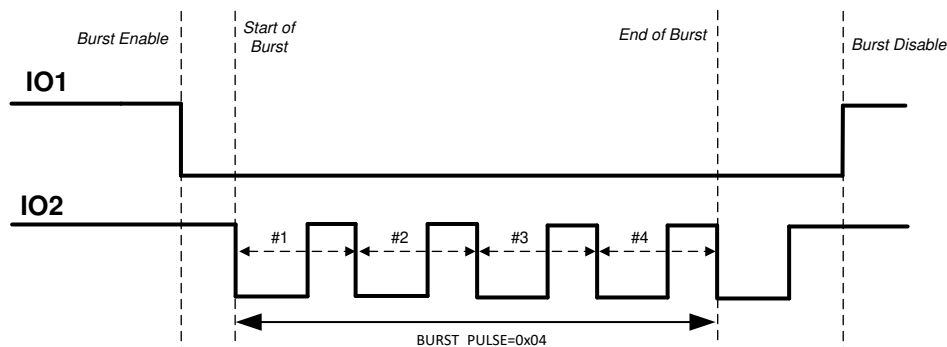


**图 7-2. IO\_MODE 1 Description**

- **IO\_MODE = 2:** In this mode both IO1 and IO2 are used to control OUTA and OUTB. The burst enable is triggered when either IO1 or IO2 transitions from high to low. Start of burst (OUTA and OUTB changing state) happens only at the next falling edge of IO1. 图 7-3 shows the case where a high-to-low transition on IO2 is used to enable the burst. A burst is emulated when IO1 and IO2 are toggled in a non-overlapping sequence. After the start of burst, the state of OUTA and OUTB pins are determined by IO1 and IO2 pins. During a burst, if there is a condition where both IO1 and IO2 are high for more than half period of the internal clock  $f_{INT\_CLK}$  (caused by differential delays due to PCB parasitics or MCU code), an end of burst and burst mode disable will be triggered. Any falling edge just after this condition will be ignored to toggle OUTA and OUTB as it would be considered as a new burst enable signal. A systematic condition of overlap can cause a continuous end of burst trigger such that OUTA and OUTB do not toggle even though IO1 and IO2 are toggling. TI recommends no overlap or minimum non-overlap between the IO1 and IO2 signals when measured at the pins. BURST\_PULSE has no effect in this mode.

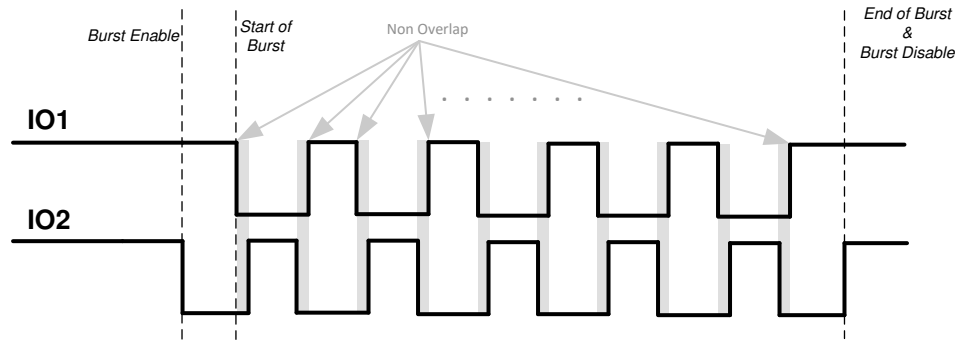


图 7-3. IO\_MODE 2 Description

- **IO\_MODE = 3:** In this mode, burst enable and start of burst are both triggered by the falling edge of IO2. TI recommends that IO2 pin is kept pulled up to VDD for this mode. The device then expects a clock at IO2 pin to generate pulses on the OUTA/OUTB pins (see 图 7-4). The number of pulses are counted by counting falling edge to next falling edge transitions on IO2 once the start of burst is triggered. End of burst sequence is signaled when the number of pulses defined in **BURST\_PULSE** are sent. After end of burst, a blank-out timer interval defined by the **DRV\_PLS\_FLT\_DT** register is started to prevent triggering of a new start of burst in the event if the IO2 pin is still toggling. After the start of burst, the state of OUTA and OUTB pins are determined by IO1 and IO2 pins.

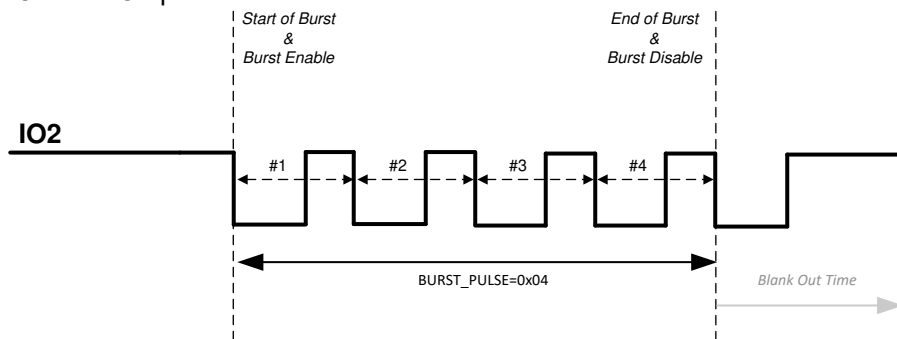


图 7-4. IO\_MODE 3 Description

## 备注

- For IO\_MODE 0 and 1, by setting **BURST\_PULSE** = 0, the device will generate continuous burst pulses on OUTA and OUTB until the end of burst is signaled through SPI or the IO1 pin, respectively. Continuous bursting is not available for IO\_MODE=3.
- A higher noise floor at the VOUT pin is expected in continuous mode where one transducer is used to transmit burst signals and another transducer is used to receive, as the switching noise of the digital IO pins can couple into the highly sensitive analog front end for the receive channel. This also applies to the single transducer use case where a continuous clock is applied on IO2 pin when the device is in indirect or listening mode.
- The range for frequency of switching for the output drivers is given by  $f_{DRV\_CLK}$  parameter in the [Switching Characteristics](#) table.
- When the device is not in direct sensing or bursting mode, the device is always in indirect sensing or listening mode.

## 7.3.2.1 Burst Generation Diagnostics

In IO\_MODE 0, 1 and 3, a pulse number diagnostic is active after start of burst (not when the burst is enabled) to monitor if the correct number of pulses (as set in **BURST\_PULSE**) were generated before the end of burst was signaled through SPI or the IO1 pin. A fault, if detected, is then reported through the **PULSE\_NUM\_FLT** bit.

The pulse duration after start of burst (not when the burst is enabled) is monitored to detect a stuck condition, which will keep the FETs on OUTA or OUTB turned on. This can happen because of loss of external clock

or the driving signal on IO1 and IO2 pins being stuck in one state. The device expects to see a toggle on IOx pins (based on IO\_MODE) within the time period as defined in the [DRV\\_PLS\\_FLT\\_DT](#) register. If this diagnostic triggers, it will force an end of burst. The fault is reported by setting the [DRV\\_PULSE\\_FLT](#) bit. If a [DRV\\_PULSE\\_FLT](#) is set in IO\_MODE 0, 1 and 3—and the programmed number of pulses were not sent before end of burst—the [PULSE\\_NUM\\_FLT](#) will also be set.

#### 备注

- The [DRV\\_PULSE\\_FLT](#) bit is cleared when a new start of burst is triggered, when [DRV\\_PLS\\_FLT\\_DT](#) = 0x7 is set, or if the device is put into Standby or Sleep mode.
- The [PULSE\\_NUM\\_FLT](#) bit is cleared when a new start of burst is triggered, or if the device is put into Standby or Sleep mode.

### 7.3.3 Direct Transducer Drive

图 7-5 shows the internal structure for driving an ultrasonic transducer connected directly to the device output using an H-bridge output stage. This configuration drives  $2 \times V_{VDRV}$  as the peak-to-peak voltage across the transducer. The voltage on VDRV pin can be set as described in the [Excitation Power Supply \(VDRV\)](#) section.

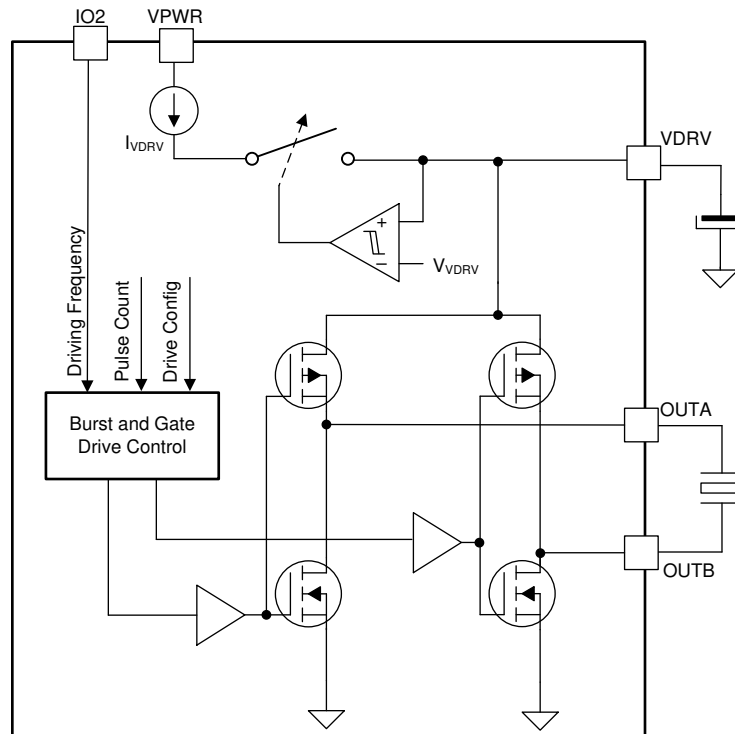


**图 7-5. Direct Drive Configuration Using Internal FETs**

图 7-5 shows the most common application case for the TUS4470 device, in which the output driver pulses the two half-bridges out-of-phase. It is also possible to use the driver in half-bridge mode by setting the [HALF\\_BRG\\_MODE](#) bit. In this mode, only  $V_{VDRV}$  is applied across the transducer. This mode is useful for transducers where one side of the membrane must be always grounded.

The device can also be configured as a pre-driver to drive external FETs or BJTs to drive higher current and voltage into the primary side of the transformer, as shown in 图 7-6, by setting the [PRE\\_DRIVER\\_MODE](#) bit. The high-side and low-side devices are used to drive the external low-side drivers. The VDRV voltage level can be configured to ensure that the OUTA and OUTB voltages do not violate the  $V_{GS}$  or  $V_{BE}$  specification for external the FET or BJT, respectively. In the configuration shown in 图 7-6, it is possible to use a voltage (VBOOST) which is higher than the supply of the system for generating higher voltage across the transducer.

Refer to [Application and Implementation](#) for an application diagram and information on how the polarity and state of OUTA and OUTB pins are defined with respect to IO1 and IO2 pin states and other register settings.

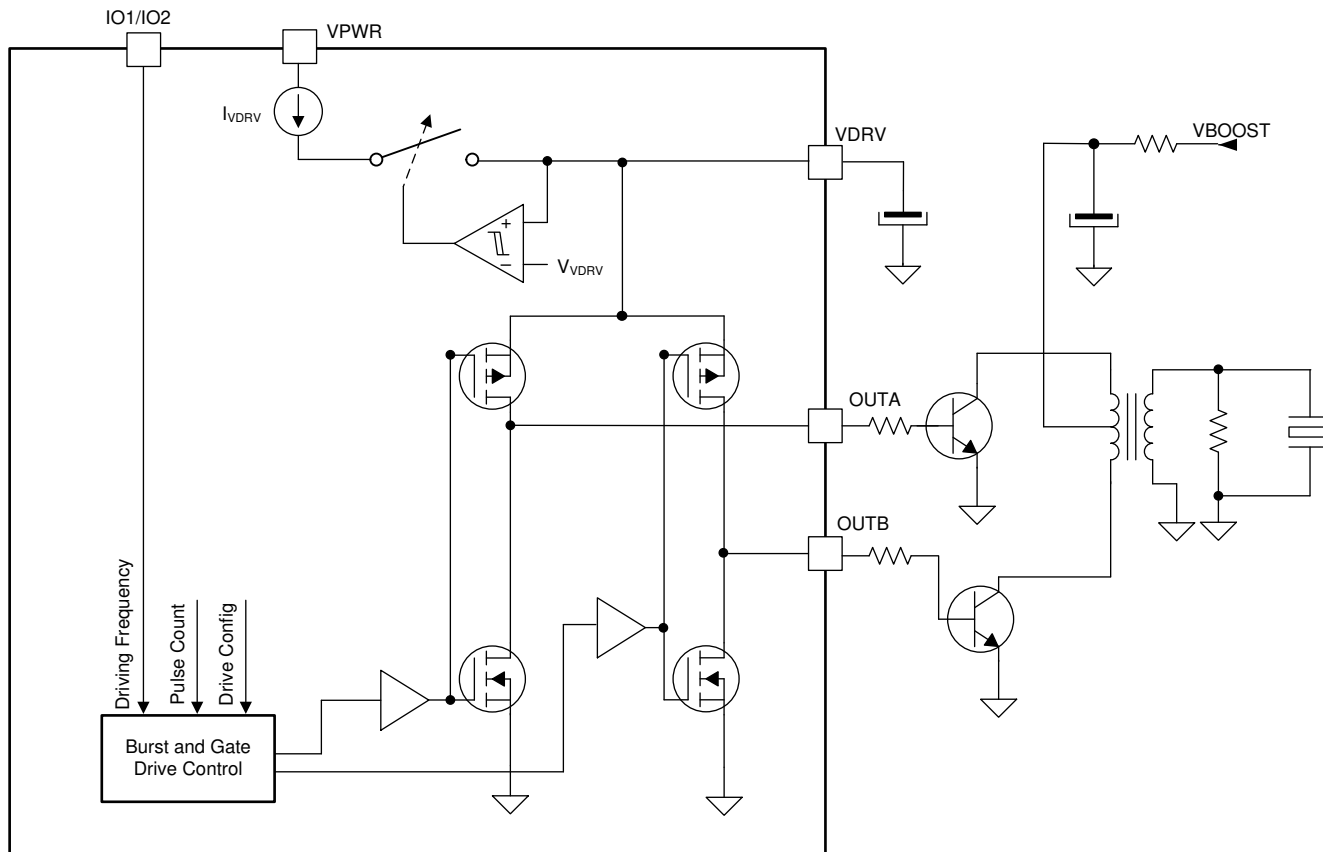


图 7-6. Center-Tap Transformer Drive Using External FETs

### 7.3.4 Analog Front End

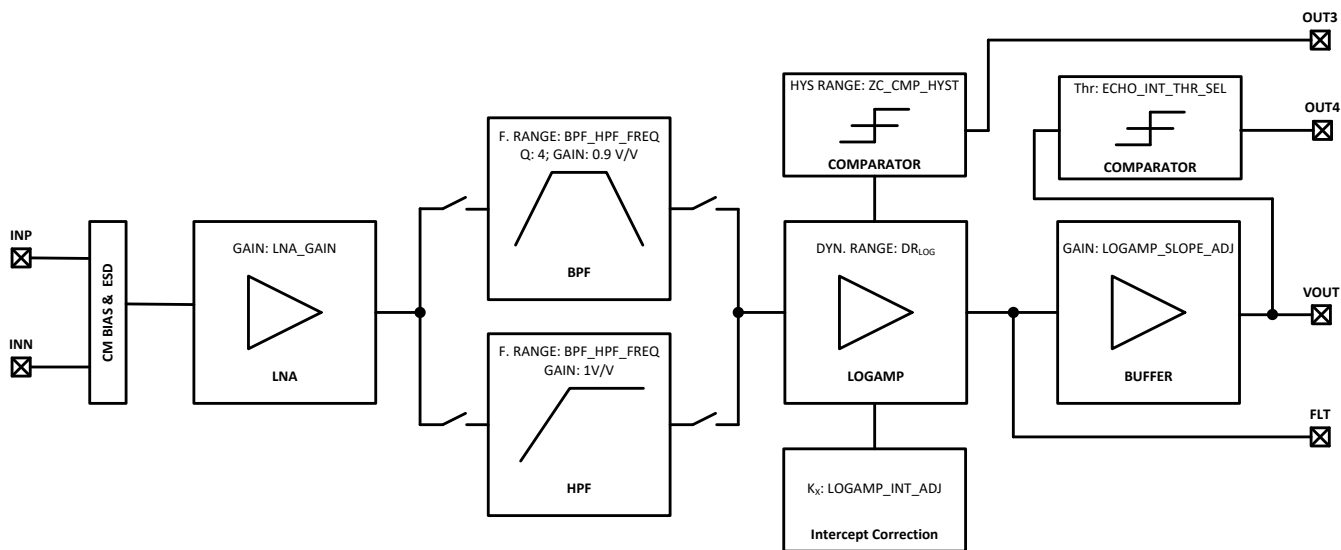


图 7-7. TUSS4470 Analog Front-End Block Diagram

图 7-7 shows the analog front-end block diagram that can receive and condition the signals from the transducer during listen mode. The received echo is first amplified with a fixed linear low-noise amplifier, followed by either a

bandpass filter or a high-pass filter to remove noise out of the expected signal band. After filtering the signal, the signal is fed into a logarithmic amplifier. The output of the logarithmic amplifier is then buffered to the VOUT pin. In 图 7-7, every block has the register name associated with it that can be used to configure the signal path. The final equation for the signal path is given by 方程式 2:

$$V_{OUT} = G_{VOUT} \cdot SL_{LOG} \cdot 20 \log_{10} \left( \frac{G_{LNA} \cdot G_{BPF} \cdot V_{IN}}{INT_{LOG} \cdot K_X} \right) \quad (1)$$

where

- $G_{VOUT}$  is set by the [LOGAMP\\_SLOPE\\_ADJ](#) bits.
- $SL_{LOG}$  is slope of logarithmic amplifier as specified in the [Receiver Characteristics](#) table.
- $G_{LNA}$  is set by the [LNA\\_GAIN](#) bits.
- $G_{BPF}$  is typically 0.9V/V.
- $V_{IN}$  is the input  $V_{INP}$
- $INT_{LOG}$  is logarithmic amplifier intercept specified in the [Receiver Characteristics](#) table.
- $K_X$  is the log intercept adjustment set by the [LOGAMP\\_INT\\_ADJ](#) bits.

The bandpass filter is critical for reducing noise to allow utilization of the complete dynamic range of the logarithmic amplifier. The center frequency of the bandpass filter can be configured to be close the transducer frequency which is set by the [BPF\\_HPF\\_FREQ](#) bits. 表 7-1 shows the nominal values for the BPF center frequency corresponding to the [BPF\\_HPF\\_FREQ](#) register value. The TUSS4470 supports a wide range of frequencies, therefore a factory trim is used to remove process variation for a particular pre-determined frequency. It is possible that all other frequencies listed in 表 7-1 do not correspond exactly to value of [BPF\\_HPF\\_FREQ](#) in a factory trim. The user can vary the value of the [BPF\\_HPF\\_FREQ](#) register around the desired center frequency while actively bursting and observing the VOUT signal. The value with maximum voltage at VOUT pin will be the desired setting for the [BPF\\_HPF\\_FREQ](#) register.

**表 7-1. Bandpass Filter Center Frequency Configuration**

| <b>BPF_HPF_FREQ (HEX)<br/>(BPF_FC_TRIM_FRC = 0)</b> | <b>BPF_F<sub>c</sub> (KHz)</b> |
|-----------------------------------------------------|--------------------------------|
| 0x00                                                | 40.64                          |
| 0x01                                                | 44.05                          |
| 0x02                                                | 45.6                           |
| 0x03                                                | 48.86                          |
| 0x04                                                | 50.58                          |
| 0x05                                                | 52.96                          |
| 0x06                                                | 56.75                          |
| 0x07                                                | 60.11                          |
| 0x08                                                | 62.95                          |
| 0x09                                                | 66.68                          |
| 0x0A                                                | 71.44                          |
| 0x0B                                                | 74.81                          |
| 0x0C                                                | 79.24                          |
| 0x0D                                                | 82.03                          |
| 0x0E                                                | 86.89                          |
| 0x0F                                                | 92.04                          |
| 0x10                                                | 97.49                          |
| 0x11                                                | 103.27                         |
| 0x12                                                | 109.4                          |
| 0x13                                                | 114.54                         |
| 0x14                                                | 121.33                         |
| 0x15                                                | 128.52                         |

**表 7-1. Bandpass Filter Center Frequency Configuration (continued)**

| BPF_HP_FREQ (HEX)<br>(BPF_FC_TRIM_FRC = 0) | BPF_F <sub>c</sub> (KHz) |
|--------------------------------------------|--------------------------|
| 0x16                                       | 134.58                   |
| 0x17                                       | 142.55                   |
| 0x18                                       | 151.01                   |
| 0x19                                       | 159.94                   |
| 0x1A                                       | 167.48                   |
| 0x1B                                       | 177.41                   |
| 0x1C                                       | 185.77                   |
| 0x1D                                       | 196.78                   |
| 0x1E                                       | 206.05                   |
| 0x1F                                       | 218.26                   |
| 0x20                                       | 228.54                   |
| 0x21                                       | 244.89                   |
| 0x22                                       | 256.43                   |
| 0x23                                       | 271.63                   |
| 0x24                                       | 284.43                   |
| 0x25                                       | 301.28                   |
| 0x26                                       | 319.13                   |
| 0x27                                       | 338.14                   |
| 0x28                                       | 353.97                   |
| 0x29                                       | 374.95                   |
| 0x2A                                       | 397.16                   |
| 0x2B                                       | 408.17                   |
| 0x2C                                       | 420.7                    |
| 0x2D                                       | 455.63                   |
| 0x2E                                       | 472.03                   |
| 0x2F                                       | 500                      |

The factory trim can be overridden by setting the [BPF\\_FC\\_TRIM\\_FRC](#) bit first and varying the [BPF\\_FC\\_TRIM](#) bit after. This is useful in two ways:

- If the factory trimmed bandpass filter center frequency is higher than the desired value for BPF\_HP\_FREQ = 0x00, or lower than desired value for BPF\_HP\_FREQ = 0x2F, then BPF\_FC\_TRIM can be used to recover the range.
- This setting can also be used to extend the frequency range of the bandpass filter center frequency.

The BPF\_FC\_TRIM acts like an offset on top of the BPF\_HP\_FREQ setting. [表 7-2](#) shows the nominal value of center frequency when this offset is added to the minimum and maximum BPF\_HP\_FREQ code. [图 6-11](#) shows the measured data. For BPF\_HP\_FREQ values greater than 0x08 and less than 0x27, varying BPF\_FC\_TRIM keeping BPF\_HP\_FREQ fixed is the same as setting BPF\_FC\_TRIM = 0x00 and varying BPF\_HP\_FREQ to find the optimum setting.

**表 7-2. Bandpass Filter Center Frequency Range Extension**

| BPF_HP_FREQ (hex) + BPF_FC_TRIM (hex)<br>(BPF_FC_TRIM_FRC = 1) | BPF_F <sub>c</sub> (KHz) |
|----------------------------------------------------------------|--------------------------|
| 0x00 + 0x8                                                     | 27.48                    |
| 0x00 + 0x9                                                     | 29.44                    |
| 0x00 + 0xA                                                     | 30.83                    |
| 0x00 + 0xB                                                     | 31.19                    |
| 0x00 + 0xC                                                     | 32.65                    |

**表 7-2. Bandpass Filter Center Frequency Range Extension (continued)**

| BPF_HPF_FREQ (hex) + BPF_FC_TRIM (hex)<br>(BPF_FC_TRIM_FRC = 1) | BPF_F <sub>c</sub> (KHz) |
|-----------------------------------------------------------------|--------------------------|
| 0x00 + 0xD                                                      | 34.19                    |
| 0x00 + 0xE                                                      | 35.8                     |
| 0x00 + 0xF                                                      | 38.81                    |
| 0x2F + 0x1                                                      | 523.56                   |
| 0x2F + 0x2                                                      | 554.59                   |
| 0x2F + 0x3                                                      | 587.45                   |
| 0x2F + 0x4                                                      | 622.23                   |
| 0x2F + 0x5                                                      | 651.58                   |
| 0x2F + 0x6                                                      | 690.19                   |
| 0x2F + 0x7                                                      | 731.09                   |

**备注**

- The Q factor of the filter is specified in the [Receiver Characteristics](#) table, and can be selected by the [BPF\\_Q\\_SEL](#) bits.
- The bandpass filter can also be converted into a high-pass filter by setting the [BPF\\_BYPASS](#) bit for transducer frequencies in the range above what is shown in [表 7-1](#). The corner frequency for high-pass filter is also controlled by the [BPF\\_HPF\\_FREQ](#) bits.
- [BPF\\_Q\\_SEL](#) and [BPF\\_FC\\_TRIM](#) have no effect when [BPF\\_BYPASS](#) = 1.

The logamp provides compression for large signal inputs and amplifies linearly small signal inputs. Logamp simplifies system design to detect varying strengths of echoes that happens because of difference in reflectivity of different types of objects and objects at different distances. It automatically adjusts its gain based on the input signal level. The logamp also demodulates the incoming signal.

The logamp consists of multiple gain stages and range extension stages that are combined to give a logarithmic response. The current consumption of the device can be reduced by turning off either the first stage, the last stage of the logamp, or both, by setting the [LOGAMP\\_DIS\\_FIRST](#) and [LOGAMP\\_DIS\\_LAST](#) bits. Disabling the stages will reduce the input dynamic range on the lower side of the range (see [图 6-4](#)). The pedestal noise floor will be lower because the gain stages are disabled, but the minimum detectable signal value becomes higher due to the reduced dynamic range. Depending on the received input signal strength, stages can be disabled to get optimum object detection. For very small inputs, all stages should be enabled to get maximum input dynamic range even though the noise floor is higher. [图 6-6](#), [图 6-7](#), and [图 6-8](#) show the effect on the log conformance error when all stages are enabled, when the last stage is disabled, and when both first and last stages are disabled. When stages are disabled, a lower error is obtained with a lower noise floor, but the input dynamic range is reduced.

At the output of the logamp, the user can apply an adjustment to the intercept of the logamp curve. This is denoted by the K<sub>x</sub> factor in [方程式 1](#). The intercept adjustment is controlled by the [LOGAMP\\_INT\\_ADJ](#) bits. [表 7-3](#) shows the nominal values of K<sub>x</sub> factor corresponding to register values, and [图 6-14](#) shows its effect on the transfer function.

**表 7-3. Logamp Intercept Adjustment**

| LOGAMP_INT_ADJ | K <sub>x</sub> |
|----------------|----------------|
| 0x00           | 1              |
| 0x01           | 1.155          |
| 0x02           | 1.334          |
| 0x03           | 1.54           |
| 0x04           | 1.778          |
| 0x05           | 2.054          |

表 7-3. Logamp Intercept Adjustment (continued)

| LOGAMP_INT_ADJ | K <sub>x</sub> |
|----------------|----------------|
| 0x06           | 2.371          |
| 0x07           | 2.738          |
| 0x08           | 1              |
| 0x09           | 0.931          |
| 0x0A           | 0.866          |
| 0x0B           | 0.806          |
| 0x0C           | 0.75           |
| 0x0D           | 0.698          |
| 0x0E           | 0.649          |
| 0x0F           | 0.604          |

The output of the logamp is filtered using a low-pass filter to remove the high-frequency components and provide a sufficient peak hold time for the demodulated envelope signal. The cut-off frequency of the low-pass filter is set by the internal impedance of the FLT pin and the value of an external capacitor connected to the pin. As this filter capacitance ( $C_{FLT}$ ) suppresses the high frequency fluctuations, it also slows down the response time of the logamp. Higher  $C_{FLT}$  capacitance will result in lower peak-to-peak voltage variations at VOUT, and slower rise and fall times for the VOUT voltage to reach its maximum value for a given input signal. A nominal value can be calculated using 方程式 3, and must be optimized depending on the application.

The output of the low-pass filter is buffered to the VOUT pin using an internal buffer. The buffer is designed to support an ADC input of a MCU. It is possible to change output dynamic range of the VOUT buffer using the [VOUT\\_SCALE\\_SEL](#) bit. Once the range is set, the gain of the VOUT buffer can be set by the [LOGAMP\\_SLOPE\\_ADJ](#) bits. The slope variation of the receiver analog front end is show in 图 6-13.

Echo interrupt signal is available on the OUT4 pin that goes high when the signal on the VOUT pin crosses a threshold as defined by the [ECHO\\_INT\\_THR\\_SEL](#) bits. As long as the VOUT signal is higher than this threshold, the echo interrupt signal is held high. The signal goes low asynchronously when the VOUT signal drops below the programmed threshold. This signal can be used to interrupt a MCU when an object has been detected. The threshold value is also dependent on the setting of the [VOUT\\_SCALE\\_SEL](#) bit.

A zero-crossing signal is output at the OUT3 pin which can be used to validate the frequency of the received echo signal to provide robustness against interference from other signals. This zero-crossing signal is derived from the raw amplified input signal from a particular stage as it is being demodulated in the logamp block. This function is disabled at device power up. but can be enabled by setting the [ZC\\_CMP\\_EN](#) bit. When enabled, the [ZC\\_CMP\\_STG\\_SEL](#) bits are used to select which logamp gain stage is used to generate the zero crossing signal while the [ZC\\_CMP\\_HYST](#) bits control the hysteresis of the zero-crossing comparator. The stage selection to see the OUT3 pin toggling depends on the strength of signal received by the logamp and has to be configured depending on the application. For large amplitude of input signal, a lower stage of the logamp should be selected, whereas for lower amplitude signal, a higher stage should be selected. To avoid switching noise generated by the toggling of the zero-crossing comparator when the [ZC\\_EN\\_ECHO\\_INT](#) bit is set, the zero-crossing output will be only enabled while the echo interrupt signal is high.

## 7.4 Device Functional Modes

The device has four functional modes:

|                   |                                                                                                                                                                                                                                                                                                                                                                                    |
|-------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>Sleep Mode</b> | Ultra-low current consumption sleep mode                                                                                                                                                                                                                                                                                                                                           |
|                   | In this mode, all major blocks of the device are disabled, including VDRV regulation. The SPI interface is still active. This transition into and out of this mode is done using the <a href="#">SLEEP_MODE_EN</a> register bit. Upon issuing a command to exit this mode, the device transitions to other modes only when the VDRV pin reaches the programmed regulation voltage. |

|                     |                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>Standby Mode</b> | <p>Low current standby mode</p> <p>In this state, the VDRV regulation is active, but other analog blocks are shut down to reduce quiescent current consumption. The <a href="#">STDBY_MODE_EN</a> bit is used to enter and exit this mode through SPI. The device can transition very quickly from this state to one of the active states for bursting and listening.</p>                                                                                                 |
| <b>Listen Mode</b>  | <p>Default mode of the device</p> <p>This is the default mode of the device when it is not in Sleep mode or Standby mode. In this mode, there is no activity on the transmitter block and the device is actively listening for any ultrasonic signals.</p>                                                                                                                                                                                                                |
| <b>Burst Mode</b>   | <p>Mode in which the device is enabled to start a burst to drive the transducer</p> <p>In this mode, the transmitter blocks are active and enabled to drive the transducer depending on when the start of burst occurs. The receiving path is also active at the same time listening for signals at the input. This mode is entered when a burst enable event occurs and exited when an end of burst occurs as described in <a href="#">Burst Generation</a> section.</p> |

图 7-8 shows an example of the transitions between the different modes of the device for IO\_MODE = 0, where the burst is activated through a SPI command and end of burst occurs as the number of programmed pulses are sent.

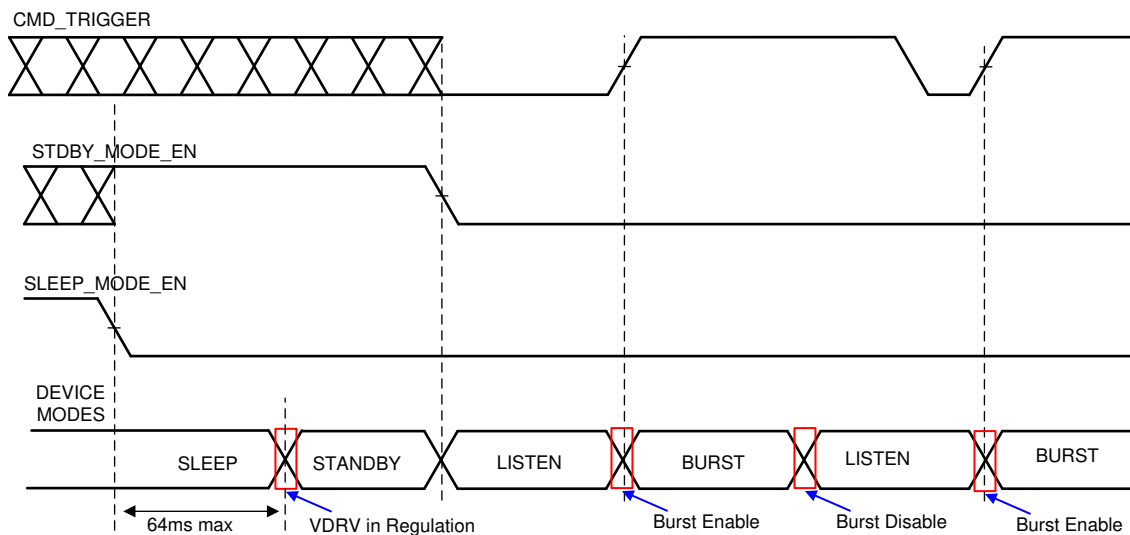


**图 7-8. Device Modes Timing Diagram**

#### 备注

- The transition to standby or active mode (listen or burst) from power-up or sleep mode is done only once the VDRV voltage crosses the programmed [VDRV\\_VOLTAGE\\_LEVEL](#) bit, or is higher 64 ms, whichever occurs earlier.
- In the case when VDRV is disabled, the device immediately transitions from power or sleep mode to standby and active modes.

## 7.5 Programming

The primary communication between the IC and the external MCU is through an SPI bus that provides full-duplex communications in a controller-peripheral configuration. The external MCU is **always** a SPI controller that sends command requests on the SDI pin and receives device responses on the SDO pin. The device is **always** a SPI peripheral device that receives command requests and sends responses to the external MCU over the SDO line. The following lists the characteristics of the SPI:

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- The SPI is a 4-pin interface.
- The frame size is 16 bits and is assigned as follows:

**Controller-to-peripheral (MCU to TUSS4470 over the SDI line)** 1 RW bit, 6 bits for the register address, 1 ODD parity bit for entire SPI frame, 8 bits for data

**Peripheral-to-controller (TUSS4470 to MCU over the SDO line)** 1 bit for Controller Parity error reporting during previous frame reception, 6 bits for the status, 1 bit for ODD parity for entire SPI frame, 8 bits for data

- SPI commands and data are shifted with the MSB first and the LSB last.
- The SDO line is sampled on the falling edge of the SCLK pin.
- The SDI line is shifted out on the rising edge of the SCLK pin.

The SPI communication begins with the NCS falling edge and ends with the NCS rising edge. The NCS high-level maintains the SPI peripheral-interface in the RESET state. The SDO output is in the tri-state condition.

The SPI does not support *back-to-back* SPI frame operation. After each SPI transfer the NCS pin must go from low to high before the next SPI transfer can begin.

Figure 7-9 shows an overview of a complete 16-bit SPI frame.

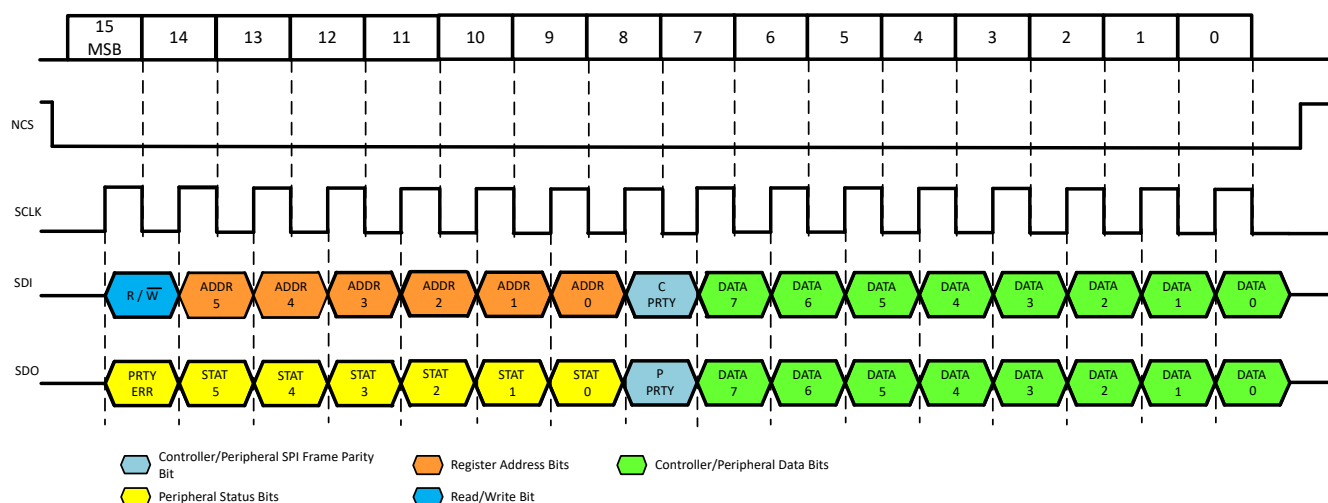


图 7-9. 16-Bit SPI Frame

Figure 7-10 shows a SPI transfer sequence between the controller and the peripheral TUSS4470 device. When the controller is writing a SPI frame, the parity error bit indicates if there was a parity error for the previous frame. When the controller is transmitting the data for the SPI write, the peripheral echoes back register address that was sent just before in the command.

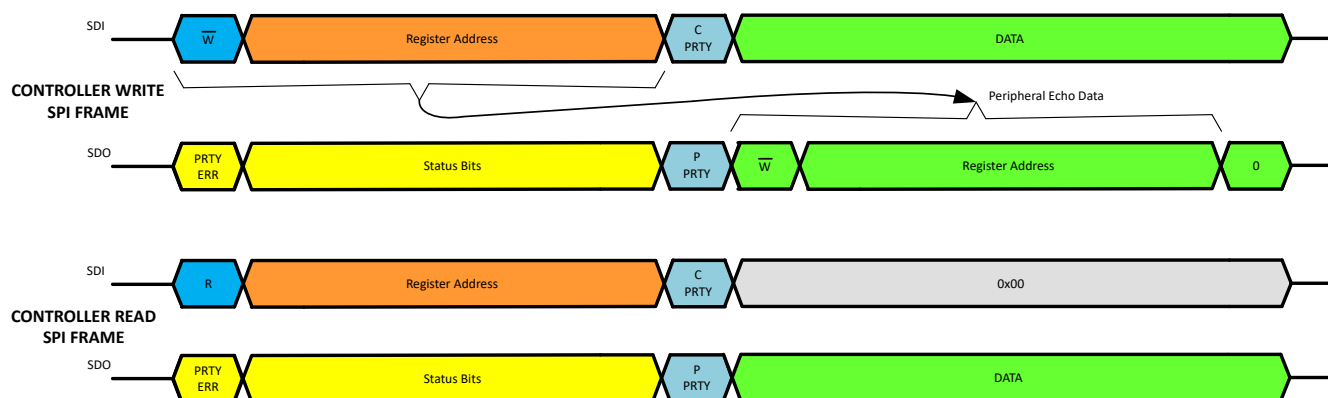


图 7-10. SPI Transfer Sequence

The status bits are defined in [表 7-4](#):

**表 7-4. SPI Interface Status Bits Description**

| STATUS BIT             | DESCRIPTION                                                                                                                                        |
|------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------|
| STAT 5 - VDRV_READY    | Set when VDRV power regulator has reached the programmed voltage level. This is also indicated by <a href="#">VDRV_READY</a> bit.                  |
| STAT 4- PULSE_NUM_FLT  | Set if the burst sequence was terminated before completing the pulse number selected. This is also indicated by <a href="#">PULSE_NUM_FLT</a> bit. |
| STAT 3 - DRV_PULSE_FLT | Set if there is a "stuck" fault detected during pulsing in a burst sequence. This is also indicated by <a href="#">DRV_PULSE_FLT</a>               |
| STAT 2 - EE_CRC_FLT    | Set if there is a CRC Error when loading internal EEPROM memory. This is also indicated by <a href="#">EE_CRC_FLT</a> bit.                         |
| STAT <1:0> - DEV_STATE | Device State:<br>00 - LISTEN<br>01 - BURST<br>10 - STANDBY<br>11 - SLEEP                                                                           |

## 7.6 Register Maps

This section lists the REG\_USER registers that are part of the volatile memory that can be configured by the MCU at power up or any time during the operation of the device. For register bits that are marked reserved, their reset value should not be changed.

### 7.6.1 REG\_USER Registers

[表 7-5](#) lists the REG\_USER registers. All register offset addresses not listed in [表 7-5](#) should be considered as reserved locations and the register contents should not be modified.

**表 7-5. REG\_USER Registers**

| Address | Acronym         | Register Name               | Section            |
|---------|-----------------|-----------------------------|--------------------|
| 0x10    | BPF_CONFIG_1    | Bandpass filter settings    | <a href="#">Go</a> |
| 0x11    | BPF_CONFIG_2    | Bandpass filter settings    | <a href="#">Go</a> |
| 0x12    | DEV_CTRL_1      | Log-amp configuration       | <a href="#">Go</a> |
| 0x13    | DEV_CTRL_2      | Log-amp configuration       | <a href="#">Go</a> |
| 0x14    | DEV_CTRL_3      | Device Configuration        | <a href="#">Go</a> |
| 0x16    | VDRV_CTRL       | VDRV Regulator Control      | <a href="#">Go</a> |
| 0x17    | ECHO_INT_CONFIG | Echo Interrupt Control      | <a href="#">Go</a> |
| 0x18    | ZC_CONFIG       | Zero Crossing configuration | <a href="#">Go</a> |
| 0x1A    | BURST_PULSE     | Burst pulse configuration   | <a href="#">Go</a> |
| 0x1B    | TOF_CONFIG      | Time of Flight Config       | <a href="#">Go</a> |
| 0x1C    | DEV_STAT        | Fault status bits           | <a href="#">Go</a> |
| 0x1D    | DEVICE_ID       | Device ID                   | <a href="#">Go</a> |
| 0x1E    | REV_ID          | Revision ID                 | <a href="#">Go</a> |

Complex bit access types are encoded to fit into small table cells. [表 7-6](#) shows the codes that are used for access types in this section.

**表 7-6. REG\_USER Access Type Codes**

| Access Type            | Code | Description |
|------------------------|------|-------------|
| Read Type              |      |             |
| R                      | R    | Read        |
| Write Type             |      |             |
| W                      | W    | Write       |
| Reset or Default Value |      |             |

**表 7-6. REG\_USER Access Type Codes (continued)**

| Access Type | Code | Description                            |
|-------------|------|----------------------------------------|
| -n          |      | Value after reset or the default value |

**7.6.1.1 BPF\_CONFIG\_1 Register (Address = 0x10) [reset = 0x0]**

BPF\_CONFIG\_1 is shown in [表 7-7](#).

Return to the [Summary Table](#).

**表 7-7. BPF\_CONFIG\_1 Register Field Descriptions**

| Bit | Field           | Type | Reset | Description                                                                                                                                                                                                                                                                   |
|-----|-----------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | BPF_FC_TRIM_FRC | R/W  | 0x0   | Override factor settings for Bandpass filter trim and control via BPF_FC_TRIM register. Valid only when BPF_BYPASS = 0<br>0x0 = Factory trim<br>0x1 = Override Factory trim                                                                                                   |
| 6   | BPF_BYPASS      | R/W  | 0x0   | Select between Bandpass filter or high pass filter<br>0x0 = BPF Enabled<br>0x1 = HPF Enabled (BPF Bypass)                                                                                                                                                                     |
| 5:0 | BPF_HPF_FREQ    | R/W  | 0x0   | If BPF_BYPASS = 0:<br>Band pass filter center frequency. See "Bandpass filter center frequency configuration" table<br>If BPF_BYPASS = 1:<br>High pass filter corner frequency<br>0x00 - 0x0F - 200kHz<br>0x10 - 0x1F - 400kHz<br>0x20 - 0x2F - 50kHz<br>0x30 - 0x3F - 100kHz |

**7.6.1.2 BPF\_CONFIG\_2 Register (Address = 0x11) [reset = 0x0]**

BPF\_CONFIG\_2 is shown in [表 7-8](#).

Return to the [Summary Table](#).

**表 7-8. BPF\_CONFIG\_2 Register Field Descriptions**

| Bit | Field       | Type | Reset | Description                                                                                                                                                 |
|-----|-------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7:6 | RESERVED    | R    | 0x0   | Reserved                                                                                                                                                    |
| 5:4 | BPF_Q_SEL   | R/W  | 0x0   | Bandpass filter Q factor. Valid only when BPF_BYPASS = 0<br>0x0 = 4<br>0x1 = 5<br>0x2 = 2<br>0x3 = 3                                                        |
| 3:0 | BPF_FC_TRIM | R/W  | 0x0   | Offset BPF_HPF_FREQ when BPF_FC_TRIM_FRC = 1:<br>BPF_HPF_FREQ = BPF_HPF_FREQ + BPF_FC_TRIM<br>See "Bandpass filter center frequency range extension" table. |

**7.6.1.3 DEV\_CTRL\_1 Register (Address = 0x12) [reset = 0x0]**

DEV\_CTRL\_1 is shown in [表 7-9](#).

Return to the [Summary Table](#).

**表 7-9. DEV\_CTRL\_1 Register Field Descriptions**

| Bit | Field            | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
|-----|------------------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | LOGAMP_FRC       | R/W  | 0x0   | Override for factory settings for LOGAMP_SLOPE_ADJ and LOGAMP_INT_ADJ                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| 6:4 | LOGAMP_SLOPE_ADJ | R/W  | 0x0   | Slope or gain adjustment at the final output on VOUT pin. Slope adjustment depends on the setting of VOUT_SCALE_SEL.<br>0x0 = $3.0 \times \text{VOUT\_SCALE\_SEL} + 4.56 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x1 = $3.1 \times \text{VOUT\_SCALE\_SEL} + 4.71 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x2 = $3.2 \times \text{VOUT\_SCALE\_SEL} + 4.86 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x3 = $3.3 \times \text{VOUT\_SCALE\_SEL} + 5.01 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x4 = $2.6 \times \text{VOUT\_SCALE\_SEL} + 3.94 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x5 = $2.7 \times \text{VOUT\_SCALE\_SEL} + 4.10 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x6 = $2.8 \times \text{VOUT\_SCALE\_SEL} + 4.25 \times \text{VOUT\_SCALE\_SEL V/V}$<br>0x7 = $2.9 \times \text{VOUT\_SCALE\_SEL} + 4.4 \times \text{VOUT\_SCALE\_SEL V/V}$ |
| 3:0 | LOGAMP_INT_ADJ   | R/W  | 0x0   | Logamp Intercept adjustment. See "Logamp intercept adjustment" table in specification for values.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |

#### 7.6.1.4 DEV\_CTRL\_2 Register (Address = 0x13) [reset = 0x0]

DEV\_CTRL\_2 is shown in [表 7-10](#).

Return to the [Summary Table](#).

**表 7-10. DEV\_CTRL\_2 Register Field Descriptions**

| Bit | Field            | Type | Reset | Description                                                                                                           |
|-----|------------------|------|-------|-----------------------------------------------------------------------------------------------------------------------|
| 7   | LOGAMP_DIS_FIRST | R/W  | 0x0   | Disable first logamp stage to reduce quiescent current                                                                |
| 6   | LOGAMP_DIS_LAST  | R/W  | 0x0   | Disable last logamp stage quiescent current                                                                           |
| 3   | RESERVED         | R    | 0x0   | Reserved                                                                                                              |
| 2   | VOUT_SCALE_SEL   | R/W  | 0x0   | Select VOUT scaling<br>0x0 = Select Vout gain to map output to 3.3 V<br>0x1 = Select Vout gain to map output to 5.0 V |
| 1:0 | LNA_GAIN         | R/W  | 0x0   | Adjust LNA Gain in V/V<br>0x0 = 15 V/V<br>0x1 = 10 V/V<br>0x2 = 20 V/V<br>0x3 = 12.5 V/V                              |

#### 7.6.1.5 DEV\_CTRL\_3 Register (Address = 0x14) [reset = 0x0]

DEV\_CTRL\_3 is shown in [表 7-11](#).

Return to the [Summary Table](#).

表 7-11. DEV\_CTRL\_3 Register Field Descriptions

| Bit | Field          | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|-----|----------------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 4:2 | DRV_PLS_FLT_DT | R/W  | 0x0   | Driver Pulse Fault Deglitch Time.<br>In IO_MODE = 0 or IO_MODE = 1, DRV_PULSE_FLT will be set if start of burst is triggered and IO2 pin has not toggled for greater than deglitch Time.<br>In IO_MODE = 2, DRV_PULSE_FLT will be set if start of burst is triggered and if IO1 or IO2 do not toggle a period longer than the deglitch time except when both pins are high.<br>0x0 = 64 $\mu$ s<br>0x1 = 48 $\mu$ s<br>0x2 = 32 $\mu$ s<br>0x3 = 24 $\mu$ s<br>0x4 = 16 $\mu$ s<br>0x5 = 8 $\mu$ s<br>0x6 = 4 $\mu$ s<br>0x7 = Check Disabled |
| 1:0 | IO_MODE        | R/W  | 0x0   | Configuration for low voltage IO pins.<br>0x0 = IOMODE 0<br>0x1 = IOMODE 1<br>0x2 = IOMODE 2<br>0x3 = IOMODE 3                                                                                                                                                                                                                                                                                                                                                                                                                                |

#### 7.6.1.6 VDRV\_CTRL Register (Address = 0x16) [reset = 0x20]

VDRV\_CTRL is shown in [表 7-12](#).

Return to the [Summary Table](#).

表 7-12. VDRV\_CTRL Register Field Descriptions

| Bit | Field              | Type | Reset | Description                                                                                                                                                                                                         |
|-----|--------------------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | RESERVED           | R    | 0x0   | Reserved                                                                                                                                                                                                            |
| 6   | DIS_VDRV_REG_LSTN  | R/W  | 0x0   | Automatically disable VDRV charging in listen mode every time after burst mode is exited given VDRV_TRIGGER = 0x0.<br>0x0 = Do not automatically disable VDRV charging<br>0x1 = Automatically disable VDRV charging |
| 5   | VDRV_HI_Z          | R/W  | 0x1   | Turn off current source between VPWR and VRDV and disable VDRV regulation.<br>0x0 = VDRV not Hi-Z<br>0x1 = VDRV in Hi-Z mode                                                                                        |
| 4   | VDRV_CURRENT_LEVEL | R/W  | 0x0   | Pull up current at VDRV pin<br>0x0 = 10 mA<br>0x1 = 20 mA                                                                                                                                                           |
| 3:0 | VDRV_VOLTAGE_LEVEL | R/W  | 0x0   | Regulated Voltage at VDRV pin Value is calculated as :<br>$VDRV = VDRV\_VOLTAGE\_LEVEL + 5 [V]$                                                                                                                     |

#### 7.6.1.7 ECHO\_INT\_CONFIG Register (Address = 0x17) [reset = 0x7]

ECHO\_INT\_CONFIG is shown in [表 7-13](#).

Return to the [Summary Table](#).

表 7-13. ECHO\_INT\_CONFIG Register Field Descriptions

| Bit | Field           | Type | Reset | Description                             |
|-----|-----------------|------|-------|-----------------------------------------|
| 7:5 | RESERVED        | R    | 0x0   | Reserved                                |
| 4   | ECHO_INT_CMP_EN | R/W  | 0x0   | Enable echo interrupt comparator output |

**表 7-13. ECHO\_INT\_CONFIG Register Field Descriptions (continued)**

| Bit | Field            | Type | Reset | Description                                                                                                                                                                                                                               |
|-----|------------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 3:0 | ECHO_INT_THR_SEL | R/W  | 0x7   | Threshold level to issue interrupt on OUT4 pin. Applied to Low pass filter output.<br>If VOUT_SCALE_SEL=0x0 :<br>Threshold = 0.04 x ECHO_INT_THR_SEL + 0.4 [V]<br>If VOUT_SCALE_SEL=0x1:<br>Threshold = 0.06 x ECHO_INT_THR_SEL + 0.6 [V] |

#### 7.6.1.8 ZC\_CONFIG Register (Address = 0x18) [reset = 0x14]

ZC\_CONFIG is shown in [表 7-14](#).

Return to the [Summary Table](#).

**表 7-14. ZC\_CONFIG Register Field Descriptions**

| Bit | Field          | Type | Reset | Description                                                                                                                                                              |
|-----|----------------|------|-------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | ZC_CMP_EN      | R/W  | 0x0   | Enable Zero Cross Comparator for Frequency detection                                                                                                                     |
| 6   | ZC_EN_ECHO_INT | R/W  | 0x0   | When set, provides ZC information only when object is detected                                                                                                           |
| 5   | ZC_CMP_IN_SEL  | R/W  | 0x0   | Zero Comparator Input Select<br>0x0 = INP - VCM<br>0x1 = INP - INN                                                                                                       |
| 4:3 | ZC_CMP_STG_SEL | R/W  | 0x2   | Zero Cross Comparator Stage Select                                                                                                                                       |
| 2:0 | ZC_CMP_HYST    | R/W  | 0x4   | Zero Cross Comparator Hysteresis Selection<br>0x0 = 30 mV<br>0x1 = 80 mV<br>0x2 = 130 mV<br>0x3 = 180 mV<br>0x4 = 230 mV<br>0x5 = 280 mV<br>0x6 = 330 mV<br>0x7 = 380 mV |

#### 7.6.1.9 BURST\_PULSE Register (Address = 0x1A) [reset = 0x0]

BURST\_PULSE is shown in [表 7-15](#).

Return to the [Summary Table](#).

**表 7-15. BURST\_PULSE Register Field Descriptions**

| Bit | Field           | Type | Reset | Description                                                                                                                                                                              |
|-----|-----------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | HALF_BRG_MODE   | R/W  | 0x0   | Use output driver in half-bridge mode.<br>When enabled, drive both high-side FET together and low-side FETs together.<br>0x0 = Disable half-bridge mode<br>0x1 = Enable half bridge mode |
| 6   | PRE_DRIVER_MODE | R/W  | 0x0   | Pre-driver mode to drive external FETs<br>0x0 = Disable pre-driver mode<br>0x1 = Enable pre-driver mode                                                                                  |
| 5:0 | BURST_PULSE     | R/W  | 0x0   | Number of burst pulses. REG_VALUE=0x00 enables continuous burst mode                                                                                                                     |

#### 7.6.1.10 TOF\_CONFIG Register (Address = 0x1B) [reset = 0x0]

TOF\_CONFIG is shown in [表 7-16](#).

Return to the [Summary Table](#).

**表 7-16. TOF\_CONFIG Register Field Descriptions**

| Bit | Field         | Type | Reset | Description                                                                                                                                                             |
|-----|---------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | SLEEP_MODE_EN | R/W  | 0x0   | For entering or exiting sleep mode<br>0x0 = Wake up or exit Sleep Mode<br>0x1 = Enter sleep mode                                                                        |
| 6   | STDBY_MODE_EN | R/W  | 0x0   | For entering or exiting standby mode<br>0x0 = Exit Standby Mode<br>0x1 = Enter Standby mode                                                                             |
| 5:2 | RESERVED      | R    | 0x0   | Reserved                                                                                                                                                                |
| 1   | VDRV_TRIGGER  | R/W  | 0x0   | Control charging of VDRV pin when DIS_VDRV_REG_LSTN = 1.<br>This has no effect when VDRV_HI_Z=0x1.<br>0x0 = Disable I <sub>VDRV</sub><br>0x1 = Enable I <sub>VDRV</sub> |
| 0   | CMD_TRIGGER   | R/W  | 0x0   | For IO_MODE=0x0, control enabling of burst mode. Ignored for other IO_MODE values.<br>0x0 = Disable burst mode<br>0x1 = Enable burst mode                               |

#### 7.6.1.11 DEV\_STAT Register (Address = 0x1C) [reset = 0x0]

DEV\_STAT is shown in [表 7-17](#).

Return to the [Summary Table](#).

**表 7-17. DEV\_STAT Register Field Descriptions**

| Bit | Field         | Type | Reset | Description                                                                                                            |
|-----|---------------|------|-------|------------------------------------------------------------------------------------------------------------------------|
| 7:4 | RESERVED      | R    | 0x0   | Reserved                                                                                                               |
| 3   | VDRV_READY    | R    | 0x0   | VDRV pin voltage status<br>0x0 = VDRV is below configured voltage<br>0x1 = VDRV is equal or above configured voltage   |
| 2   | PULSE_NUM_FLT | R    | 0x0   | The Driver has not received the number of pulses defined by BURST_PULSE                                                |
| 1   | DRV_PULSE_FLT | R    | 0x0   | The Driver has been stuck in a single state in burst mode for a period longer than delgitch time set by DRV_PLS_FLT_DT |
| 0   | EE_CRC_FLT    | R    | 0x0   | CRC error for internal memory                                                                                          |

#### 7.6.1.12 DEVICE\_ID Register (Address = 0x1D) [reset = X]

DEVICE\_ID is shown in [表 7-18](#).

Return to the [Summary Table](#).

**表 7-18. DEVICE\_ID Register Field Descriptions**

| Bit | Field     | Type | Reset | Description     |
|-----|-----------|------|-------|-----------------|
| 7:0 | DEVICE_ID | R    | X     | Device ID: 0xB9 |

#### 7.6.1.13 REV\_ID Register (Address = 0x1E) [reset = 0x2]

REV\_ID is shown in [表 7-19](#).

Return to the [Summary Table](#).

**表 7-19. REV\_ID Register Field Descriptions**

| Bit | Field  | Type | Reset | Description |
|-----|--------|------|-------|-------------|
| 7:0 | REV_ID | R    | 0x2   | Revision ID |

## 8 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 8.1 Application Information

The TUS4470 device must be paired with an external ultrasonic transducer. The TUS4470 device drives the transducer to generate an ultrasonic echo and applies logarithmic gain scaling to the received echo signal in the analog front end. The transducer should be chosen based on the resonant frequency, input voltage requirements, sensitivity, beam pattern, and decay time. The TUS4470 device is flexible enough to meet most transducer requirements by adjusting the driving frequency, driving current limit, and center frequency of the band-pass filter. The only available interface to configure the device registers is SPI. During the burst-and-listen cycles, an external ADC or analog receiver should be used to capture the echo envelope from the VOUT pin to compute time of flight (ToF), distance, amplitude, and/or width of the return echo.

### 8.2 Typical Application

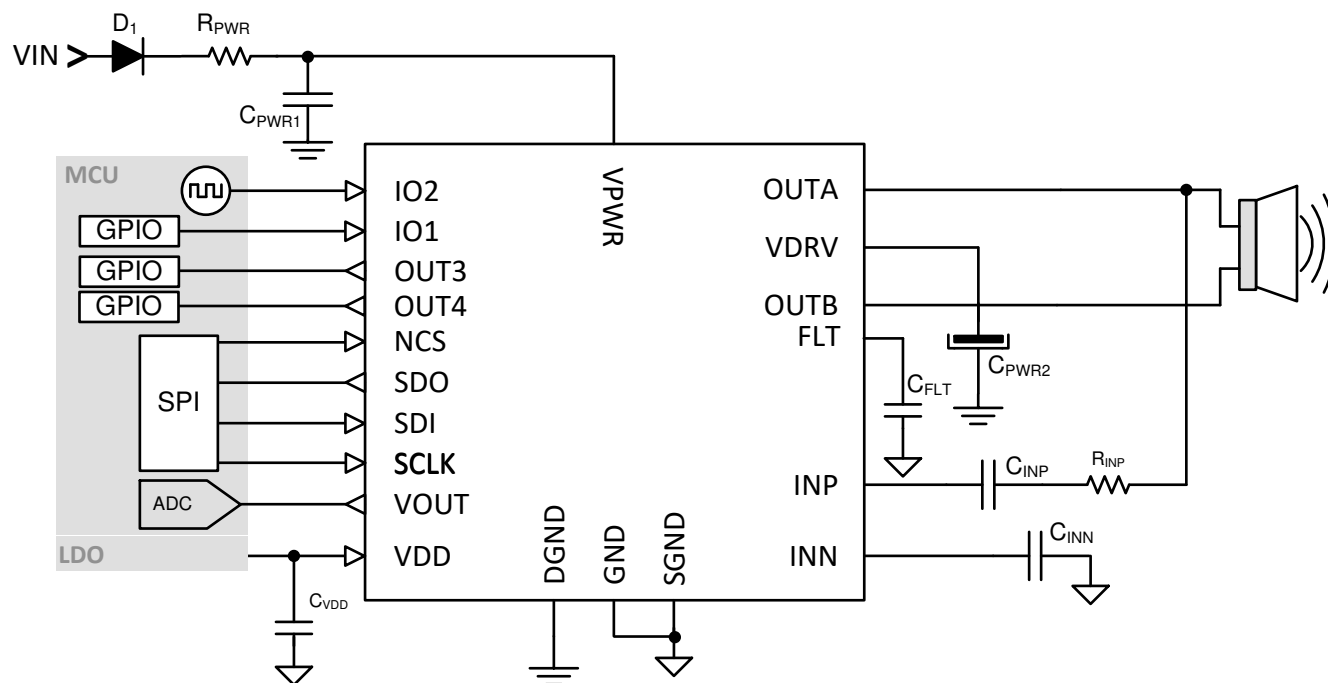


图 8-1. TUS4470 Application Diagram

**表 8-1. Recommended Component Values for Typical Applications**

| DESIGNATOR         | VALUE                 | COMMENT                                                                                                                                                                                                                                                                 |
|--------------------|-----------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| R <sub>PWR</sub>   | 10 Ω                  | Optional (to limit fast voltage transient on VPWR pin during power up)                                                                                                                                                                                                  |
| R <sub>(INP)</sub> | 200Ω (1/4 Watt)       | Optional higher value for EMI/ESD robustness                                                                                                                                                                                                                            |
| C <sub>PWR1</sub>  | 50V, 100nF            |                                                                                                                                                                                                                                                                         |
| C <sub>PWR2</sub>  | 40V, 2μF              |                                                                                                                                                                                                                                                                         |
| C <sub>VDD</sub>   | >5V, 10nF             |                                                                                                                                                                                                                                                                         |
| C <sub>INP</sub>   | 40V, 330pF            |                                                                                                                                                                                                                                                                         |
| C <sub>INN</sub>   | >5V, C <sub>INN</sub> | Use equation below to estimate value of C <sub>INN</sub> depending on the burst frequency<br>$C_{INN} = \frac{1}{2 \cdot \pi \cdot 150 \cdot \left(\frac{f_{DRV\_CLK}}{4}\right)} \quad (2)$                                                                            |
| C <sub>FLT</sub>   | 5V, C <sub>FLT</sub>  | Use equation below to estimate value of C <sub>FLT</sub> depending on the burst frequency. Value has to be optimized for application depending on noise and response time requirements.<br>$C_{FLT} = \frac{25}{2 \cdot \pi \cdot (6250 \cdot f_{DRV\_CLK})} \quad (3)$ |
| D1                 | 1N4001 or equivalent  | Optional for reverse supply and reverse current protection.                                                                                                                                                                                                             |
| XDCR (transducer)  |                       | Example devices for low-frequency range:<br>Closed top: 40 kHz: PUI Audio UTR-1440K-TT-R<br>Open top: muRata MA40H1S-R, SensComp 40LPT16, Kobitone 255-400PT160-ROX<br>Example devices for high-frequency range:<br>Closed top: 300 kHz: Murata MA300D1-1               |

### 8.2.1 Transducer Drive Configuration Options

For different transducer drive configurations, the TUSS4470 supports multiple configurations to accommodate specific system needs as shown in [图 8-2](#). The typical application diagram in [图 8-1](#) is considered as "Case 1".

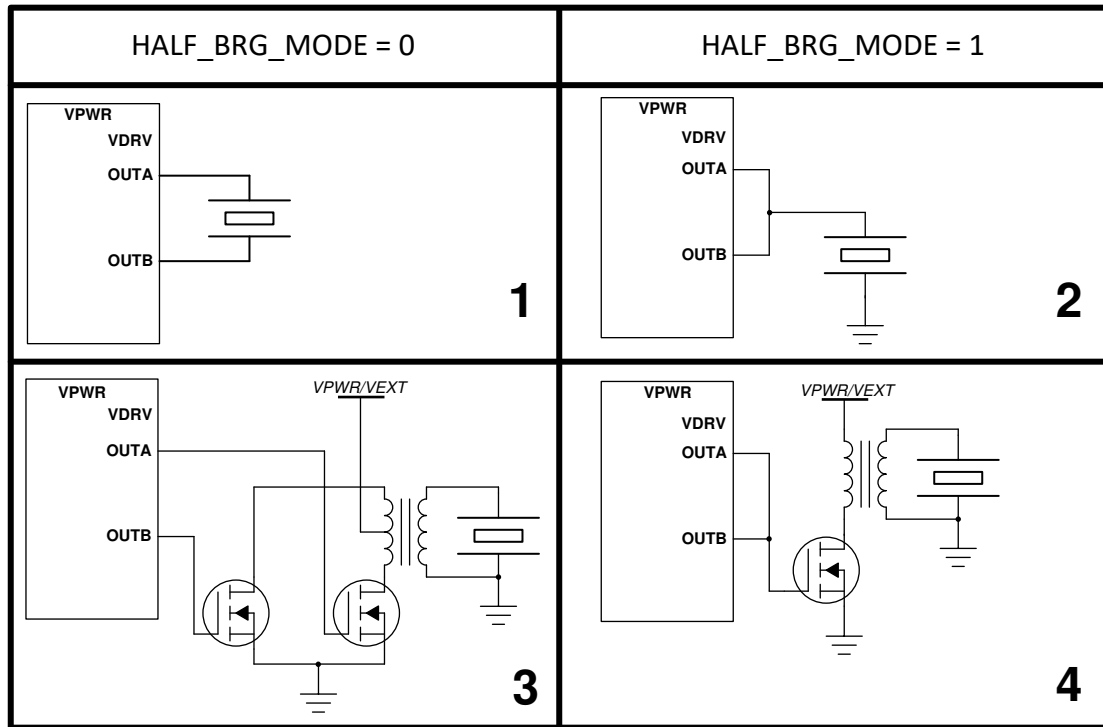


图 8-2. TUS4470 Transducer Drive Options

The behavior of the internal FETs in the TUS4470 device is different for each configuration in 图 8-2. 表 8-2 and 表 8-3 shows the relationship between the IOx pins and the state of the OUTA and OUTB pins for different register settings.

表 8-2. OUTA / OUTB Pin Behavior for Different Drive Configurations in IO MODE 2

| IO MODE 2      |                         |                   |     |     |                   |                   |                  |
|----------------|-------------------------|-------------------|-----|-----|-------------------|-------------------|------------------|
| START OF BURST | PRE_DRI<br>VER_MO<br>DE | HALF_BRG_M<br>ODE | IO1 | IO2 | OUTA              | OUTB              | APPLICATION CASE |
| YES            | 0                       | 0                 | 0   | 0   | GND               | GND               | CASE 1           |
|                | 0                       | 0                 | 0   | 1   | GND               | V <sub>VDRV</sub> |                  |
|                | 0                       | 0                 | 1   | 0   | V <sub>VDRV</sub> | GND               |                  |
| NO             | 0                       | 0                 | 1   | 1   | Hi-Z              | GND               | CASE 2           |
| YES            | 0                       | 1                 | 0   | 0   | Hi-Z              | Hi-Z              |                  |
|                | 0                       | 1                 | 0   | 1   | V <sub>VDRV</sub> | V <sub>VDRV</sub> |                  |
|                | 0                       | 1                 | 1   | 0   | GND               | GND               |                  |
| NO             | 0                       | 1                 | 1   | 1   | Hi-Z              | Hi-Z              | CASE 3           |
| YES            | 1                       | 0                 | 0   | 0   | GND               | GND               |                  |
|                | 1                       | 0                 | 0   | 1   | GND               | V <sub>VDRV</sub> |                  |
|                | 1                       | 0                 | 1   | 0   | V <sub>VDRV</sub> | GND               |                  |
| NO             | 1                       | 0                 | 1   | 1   | GND               | GND               | CASE 4           |
| YES            | 1                       | 1                 | 0   | 0   | GND               | GND               |                  |
|                | 1                       | 1                 | 0   | 1   | V <sub>VDRV</sub> | V <sub>VDRV</sub> |                  |
|                | 1                       | 1                 | 1   | 0   | GND               | GND               |                  |
| NO             | 1                       | 1                 | 1   | 1   | GND               | GND               |                  |

**表 8-3. OUTA / OUTB Pin Behavior for Different Drive Configurations in IO MODE 0, IO MODE 1 and IO MODE 3**

| IO MODE 0, IO MODE 1, IO MODE 3 |                 |               |                         |                 |     |                   |                   |                  |
|---------------------------------|-----------------|---------------|-------------------------|-----------------|-----|-------------------|-------------------|------------------|
| START OF BURST                  | PRE_DRIVER_MODE | HALF_BRG_MODE | CMD_TRIGGER (IO MODE 0) | IO1 (IO MODE 1) | IO2 | OUTA              | OUTB              | APPLICATION CASE |
| NO                              | 0               | 0             | 0                       | 1               | 0   | Hi-Z              | GND               | CASE 1           |
|                                 | 0               | 0             | 0                       | 1               | 1   |                   |                   |                  |
| YES                             | 0               | 0             | 1                       | 0               | 0   | GND               | V <sub>VDRV</sub> |                  |
|                                 | 0               | 0             | 1                       | 0               | 1   | V <sub>VDRV</sub> | GND               |                  |
| NO                              | 0               | 1             | 0                       | 1               | 0   | Hi-Z              | Hi-Z              | CASE 2           |
|                                 | 0               | 1             | 0                       | 1               | 1   |                   |                   |                  |
| YES                             | 0               | 1             | 1                       | 0               | 0   | GND               | GND               |                  |
|                                 | 0               | 1             | 1                       | 0               | 1   | V <sub>VDRV</sub> | V <sub>VDRV</sub> |                  |
| NO                              | 1               | 0             | 0                       | 1               | 0   | GND               | GND               | CASE 3           |
|                                 | 1               | 0             | 0                       | 1               | 1   |                   |                   |                  |
| YES                             | 1               | 0             | 1                       | 0               | 0   | GND               | V <sub>VDRV</sub> |                  |
|                                 | 1               | 0             | 1                       | 0               | 1   | V <sub>VDRV</sub> | GND               |                  |
| NO                              | 1               | 1             | 0                       | 1               | 0   | GND               | GND               | CASE 4           |
|                                 | 1               | 1             | 0                       | 1               | 1   |                   |                   |                  |
| YES                             | 1               | 1             | 1                       | 0               | 0   | GND               | GND               |                  |
|                                 | 1               | 1             | 1                       | 0               | 1   | V <sub>VDRV</sub> | V <sub>VDRV</sub> |                  |

### 8.2.1.1 Design Requirements

For this design example, use the parameters listed in 表 8-4 as the input and operating parameters. All other device settings can be assumed to be factory default.

**表 8-4. Design Parameters**

| DESIGN PARAMETER           | EXAMPLE VALUE                           |
|----------------------------|-----------------------------------------|
| Input voltage range        | 5 to 36 V                               |
| Input voltage recommended  | 5 V or 20 V                             |
| Transducer driving voltage | 5 V <sub>AC</sub> or 20 V <sub>AC</sub> |
| Transducer frequency       | 40 kHz or 400 kHz                       |
| Transducer pulse count     | 16                                      |

### 8.2.1.2 Detailed Design Procedure

To begin the design process, determine the following:

- Transducer
  - Transducer driving voltage
  - Transducer resonant frequency
  - Transducer pulse count maximum

#### 8.2.1.2.1 Transducer Driving Voltage

When a voltage is applied to piezoelectric ceramics, mechanical distortion is generated according to the voltage and frequency. The mechanical distortion is measured in units of sound pressure level (SPL) to indicate the volume of sound, and can be derived from a free-field microphone voltage measurement using 方程式 4.

$$\text{SPL (db)} = 20 \times \log \frac{\left( \frac{V_{(\text{MIC})}}{3.4 \text{ mV}} \right)}{P_O} \quad (4)$$

where

- $V_{(MIC)}$  is the measured sensor sound pressure ( $mV_{RMS}$ ).
- $P_O$  is a referenced sound pressure of 20  $\mu Pa$ .

The SPL does not increase indefinitely with the driving voltage. After a particular driving voltage, the amount of SPL that a transducer can generate becomes saturated. A transducer is given a maximum driving voltage specification to indicate when the maximum SPL is generated. Driving the transducer beyond the maximum driving voltage makes the ultrasonic module less power-efficient and can damage or decrease the life expectancy of the transducer.

#### 8.2.1.2.2 Transducer Driving Frequency

The strength of ultrasonic waves propagated into the air attenuate proportionally with distance. This attenuation is caused by diffusion, diffraction, and absorption loss as the ultrasonic energy transmits through the medium of air. As shown in 图 8-3, the higher the frequency of the ultrasonic wave, the larger the attenuation rate and the shorter the distance the wave reaches.

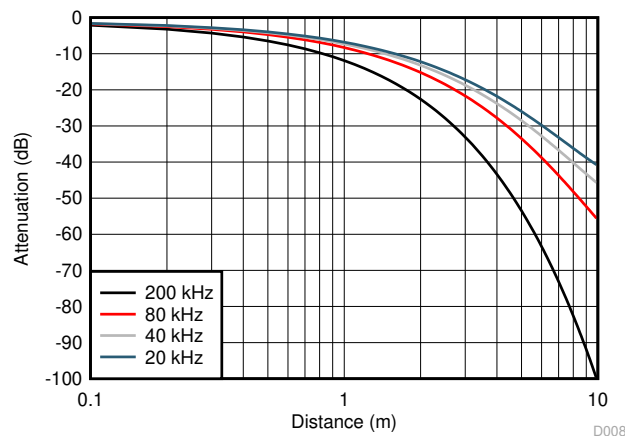


图 8-3. Attenuation Characteristics of Sound Pressure by Distance

An ultrasonic transducer has a fixed resonant center frequency with a typical tolerance of  $\pm 2\%$ . The lower frequency range of 30 kHz to 100 kHz is the default operating range for common long range applications for a step resolution of 1 cm and typical range of 30 cm to 5 m. The upper frequency range of 100 kHz to 1000 kHz is reserved for high-precision applications with a step resolution of 1 mm and a typical range of 5 cm to 1 m.

#### 8.2.1.2.3 Transducer Pulse Count

The pulse count determines how many alternating periods are applied to the transducer by the complementary low-side drivers and determines the total width of the ultrasonic ping that was transmitted. The larger the width of the transmitted ping, the larger the width of the returned echo signature of the reflected surface and the more resolution available to set a stable threshold. A disadvantage of a large pulse count is a large ringing-decay period, which limits how detectable objects are at short distances.

Select a pulse count based on the minimum object distance requirement. If short-distance object detection is not a priority, a high pulse count is not a concern. Certain transducers can be driven continuously while others have a limit to the maximum driving-pulse count. Refer to the specification for the selected transducer to determine if the pulse count must be limited.

### 8.2.1.3 Application Curves

图 8-4 和 图 8-5 显示 40-kHz 闭顶式传感器的典型测距性能。测试对象为 PVC 杆，高度为 1000 mm，直径为 75 mm。设备设置：LNA\_GAIN = 0x0; VOUT\_SCALE\_SEL = 0x0; LOGAMP\_DIS\_FIRST = 0x0; LOGAMP\_DIS\_LAST = 0x1。

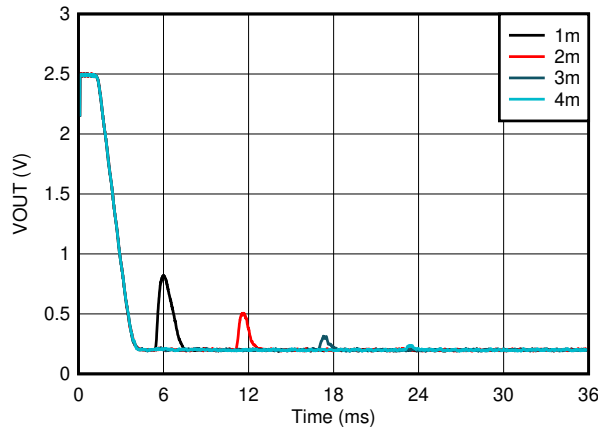


图 8-4. TUSS4470 40 kHz Ranging at 5-V Driver With Last Log-Amp Stage Disabled

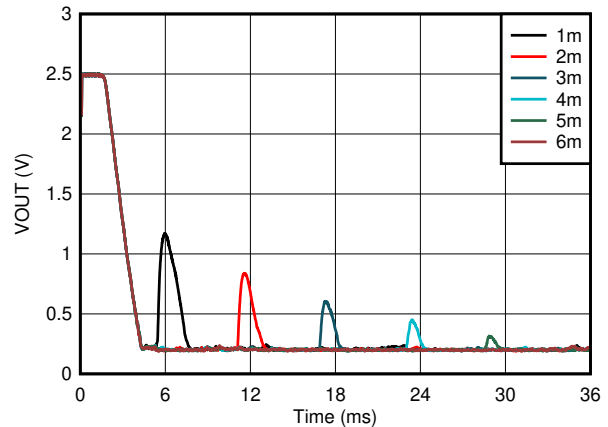


图 8-5. TUSS4470 40 kHz Ranging at 20-V Driver With Last Log-Amp Stage Disabled

图 8-6 和 图 8-7 显示 400-kHz 闭顶式传感器的典型测距性能。测试对象为铝杆，高度为 100 mm，直径为 10 mm。设备设置：LNA\_GAIN = 0x0; VOUT\_SCALE\_SEL = 0x0; LOGAMP\_DIS\_FIRST = 0x0; LOGAMP\_DIS\_LAST = 0x0。

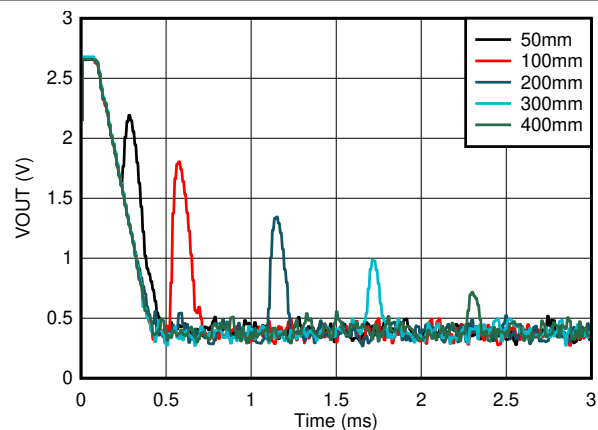


图 8-6. TUSS4470 400 kHz Ranging at 5-V Drive

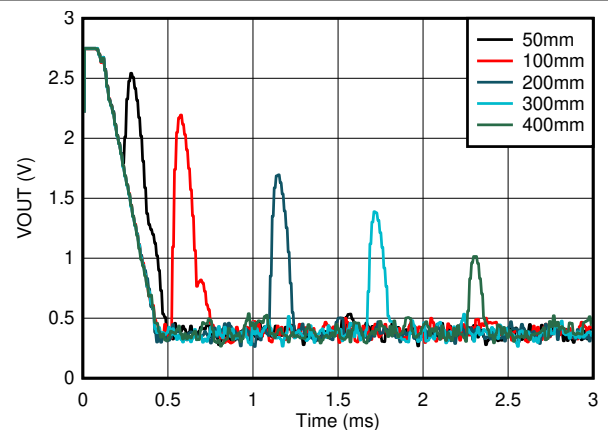


图 8-7. TUSS4470 400 kHz Ranging at 20-V Driver

## 9 Power Supply Recommendations

The TUS4470 device is designed to operate from two independent supplies, a driver supply and a regulated supply.

The driver input voltage supply (VPWR) range can operate from 5 V to 36 V. In applications where the TUS4470 device may be exposed to battery transients and reverse battery currents, use external component-safeguards, such as component D1 or parallel TVS diodes, to help protect the device. If the input supply is placed more than a few inches from the TUS4470 device, additional bulk capacitance may be required in addition to the ceramic bypass capacitors near the VPWR pin. In the event both the VDRV and pre-driver modes is enabled, limit the VPWR voltage to the maximum rated voltage of the externally driven transistor's gate-source or base-emitter rating. The electrolytic capacitor at the VDRV pin is intended to act as a fast discharge capacitor during the bursting stage of the TUS4470 device. The H-bridge high-side voltage can be supplied with an independent voltage at the VDRV pin to isolate the driver from VPWR, but must remain within the specified maximum voltage rating of the VDRV, OUTA, and OUTB outputs. If the H-bridge high-side voltage is to be supplied by an independent source, VDRV should be disabled.

The regulated supply (VDD) is used as the supply reference for the analog front end, filtering, and analog output blocks, so this supply should be stable for maximum performance. TI recommends using an LDO or other regulated external power source with bypass capacitor placed closely to the VDD pin. As VDD becomes less stable, the noise floor of the VOUT signal will increase, and result in a loss of long range object detection as a consequence.

To prevent damage to the device, always avoid hot-plugging or providing instantaneous power at the VPWR and VDRV pins at start-up, unless these pins are properly protected with an RC filter or TVS diode to minimize transient effects. VPWR must always be equal to or greater than the value present at VDRV.

## 10 Layout

### 10.1 Layout Guidelines

A minimum of two layers is required to accomplish a small-form factor ultrasonic module design. The layers should be separated by analog and digital signals. The pin map of the device is routed such that the power and digital signals are on the opposing side of the analog driver and receiver pins. Consider the following best practices for TUSS4470 device layout in order of descending priority:

- Separating the grounding types is important to reduce noise at the AFE input of the TUSS4470. In particular, the transducer sensor ground, supporting driver, and return-path circuitry should have a separate ground before being connected to the main ground. Separating the sensor and main grounds through a ferrite bead is best practice, but not require. A copper-trace or 0- $\Omega$  short is also acceptable when bridging grounds.
- The analog return path pins, INP and INN, are most susceptible to noise and therefore should be routed as short and directly to the transducer as possible. Ensure the INN capacitor is close to the pin to reduce the length of the ground wire.
- The analog output pin trace should be routed as short and directly to an external ADC or microcontroller input to avoid signal-to-noise losses due to parasitic-effects or noise coupling onto the trace from external radiating aggressors.
- In applications where protection from an ESD strike on the case of the transducer is important, ground routing of the capacitor on the INN pin should be separate from the device ground and connected directly with the shortest possible trace to the connector ground.
- The analog drive pins can be high-current, high-voltage, or both and therefore the design limitation of the OUTA and OUTB pins is based on the copper trace profile. The driver pins are recommended to be as short and direct as possible when driving a transducer with a high-voltage.
- The decoupling capacitors for the VDD and VPWR pins should be placed as close to the pins as possible.
- Any digital communication should be routed away from the analog receiver pins. TXD, RXD, SCLK, NCS, IO1, IO2, OUT3, and OUT4 pins should be routed on the opposite side of the PCB, away from of the analog signals.

## 10.2 Layout Example

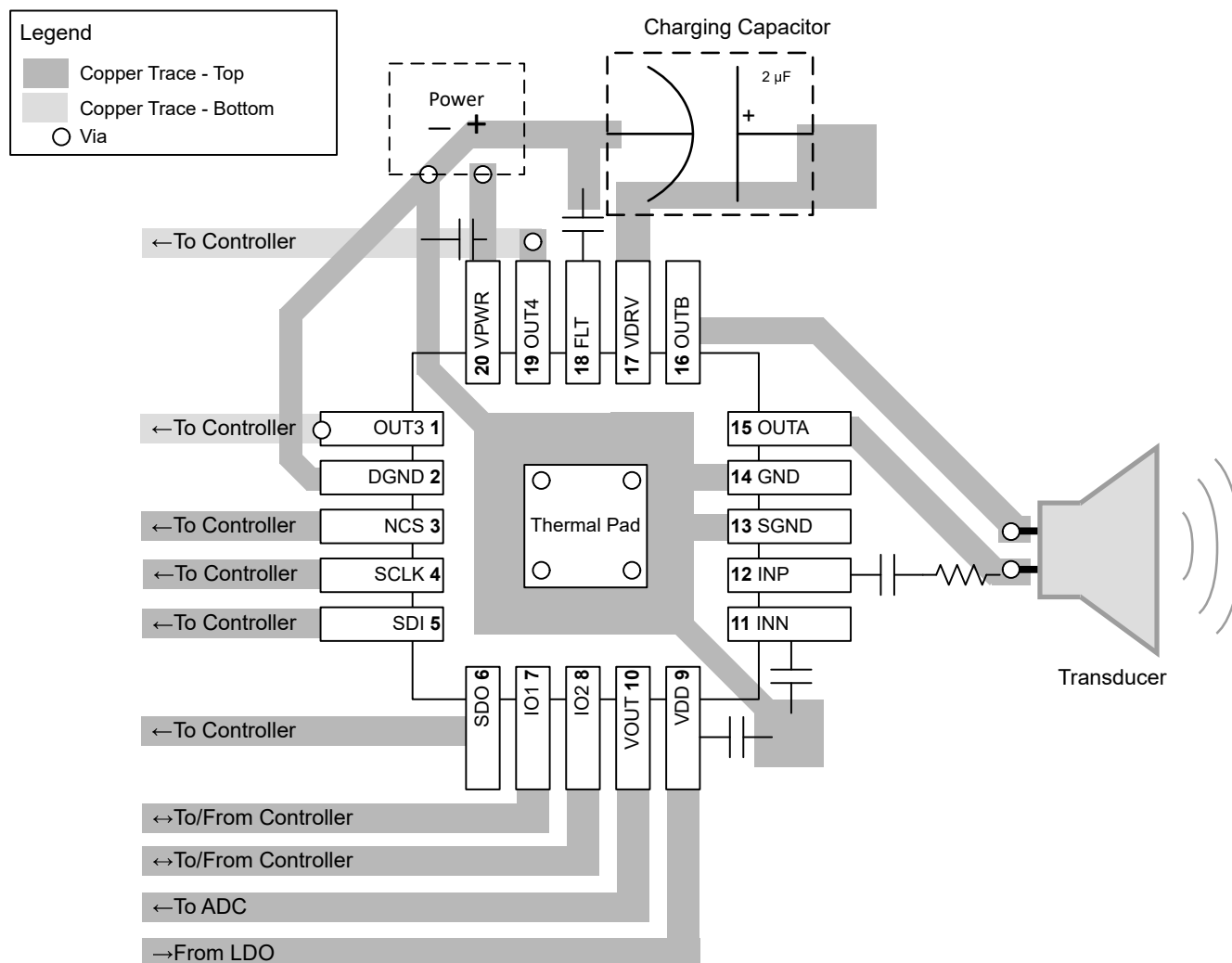


图 10-1. TUSS4470 Layout Example

## 11 Device and Documentation Support

### 11.1 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 11.2 支持资源

[TI E2E™ 支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

### 11.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.  
所有商标均为其各自所有者的财产。

### 11.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 11.5 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number         | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-------------------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">TUSS4470TRTJR</a> | Active        | Production           | QFN (RTJ)   20 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -25 to 105   | USS4470             |
| TUSS4470TRTJR.A               | Active        | Production           | QFN (RTJ)   20 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -25 to 105   | USS4470             |
| <a href="#">TUSS4470TRTJT</a> | Obsolete      | Production           | QFN (RTJ)   20 | -                     | -           | Call TI                              | Call TI                           | -25 to 105   | USS4470             |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

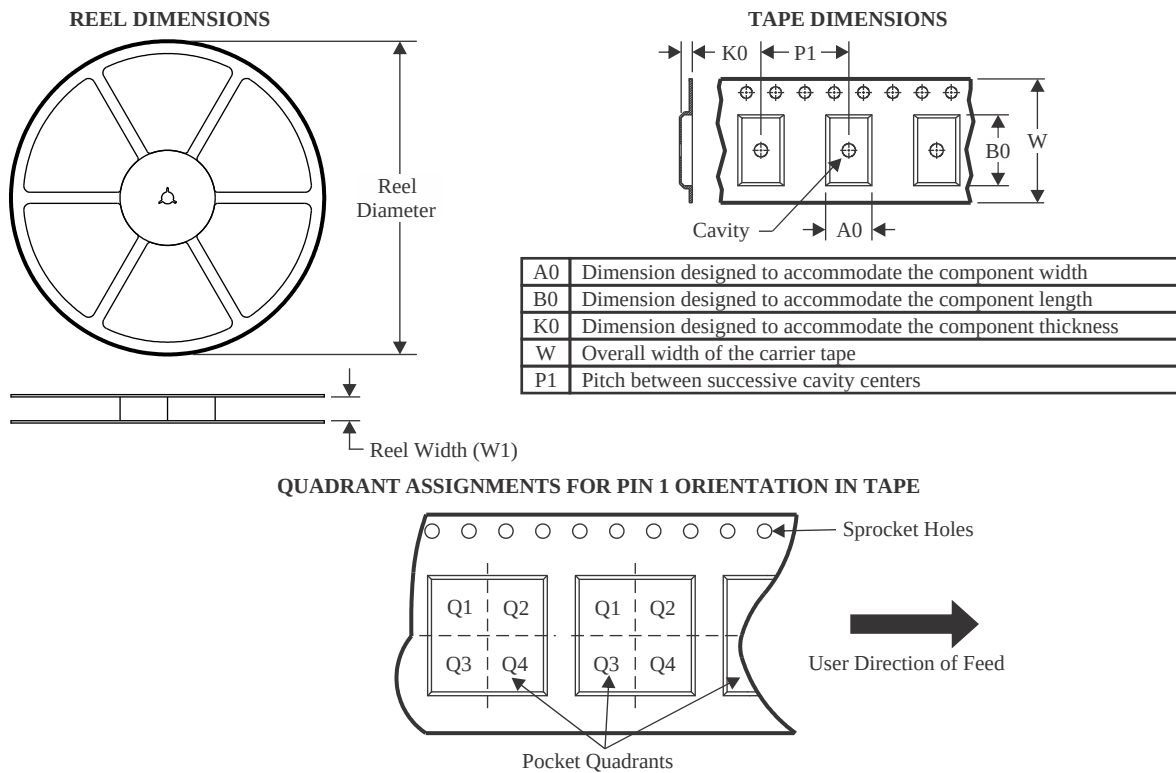
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

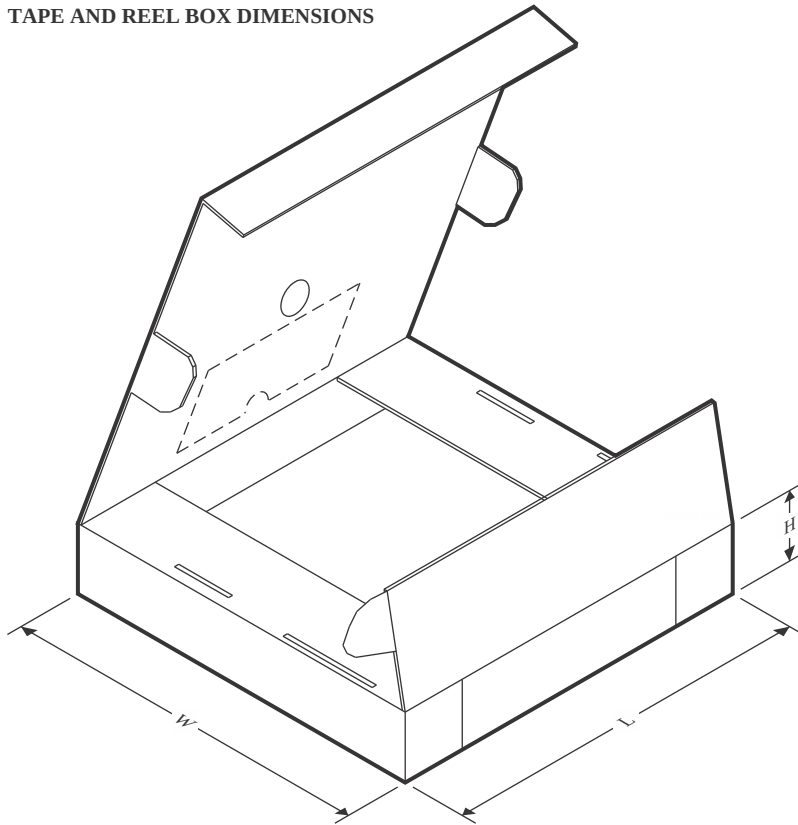
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device        | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TUSS4470TRTJR | QFN          | RTJ             | 20   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device        | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|---------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TUSS4470TRTJR | QFN          | RTJ             | 20   | 3000 | 360.0       | 360.0      | 36.0        |

## GENERIC PACKAGE VIEW

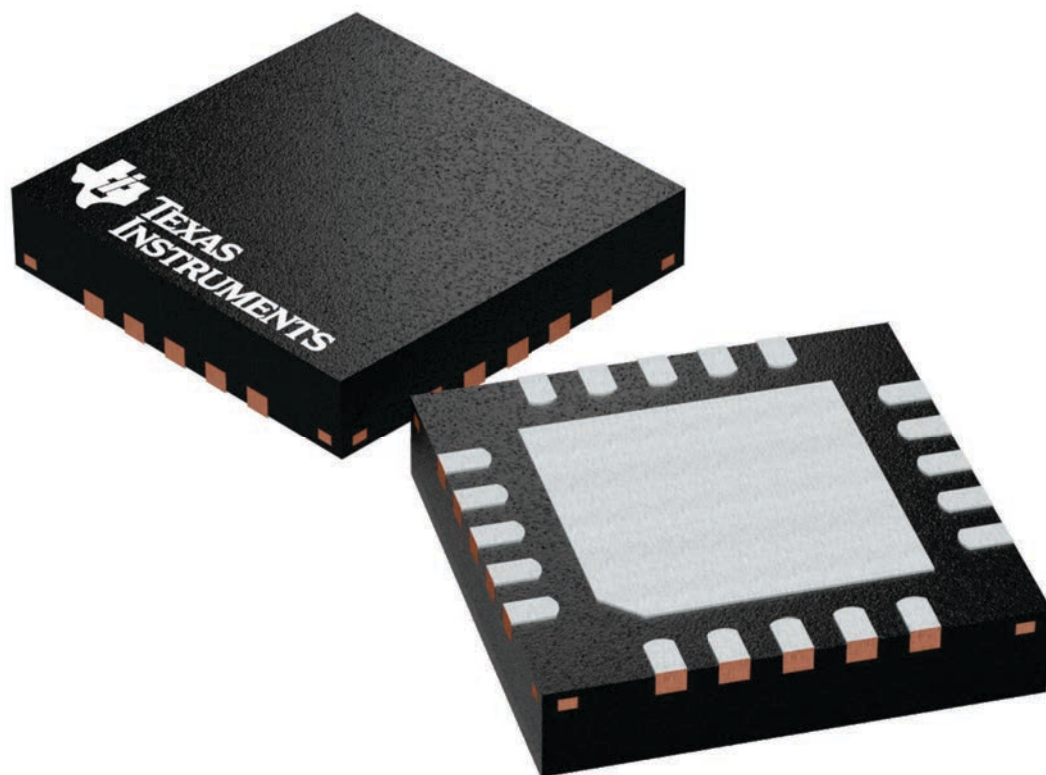
**RTJ 20**

**WQFN - 0.8 mm max height**

4 x 4, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

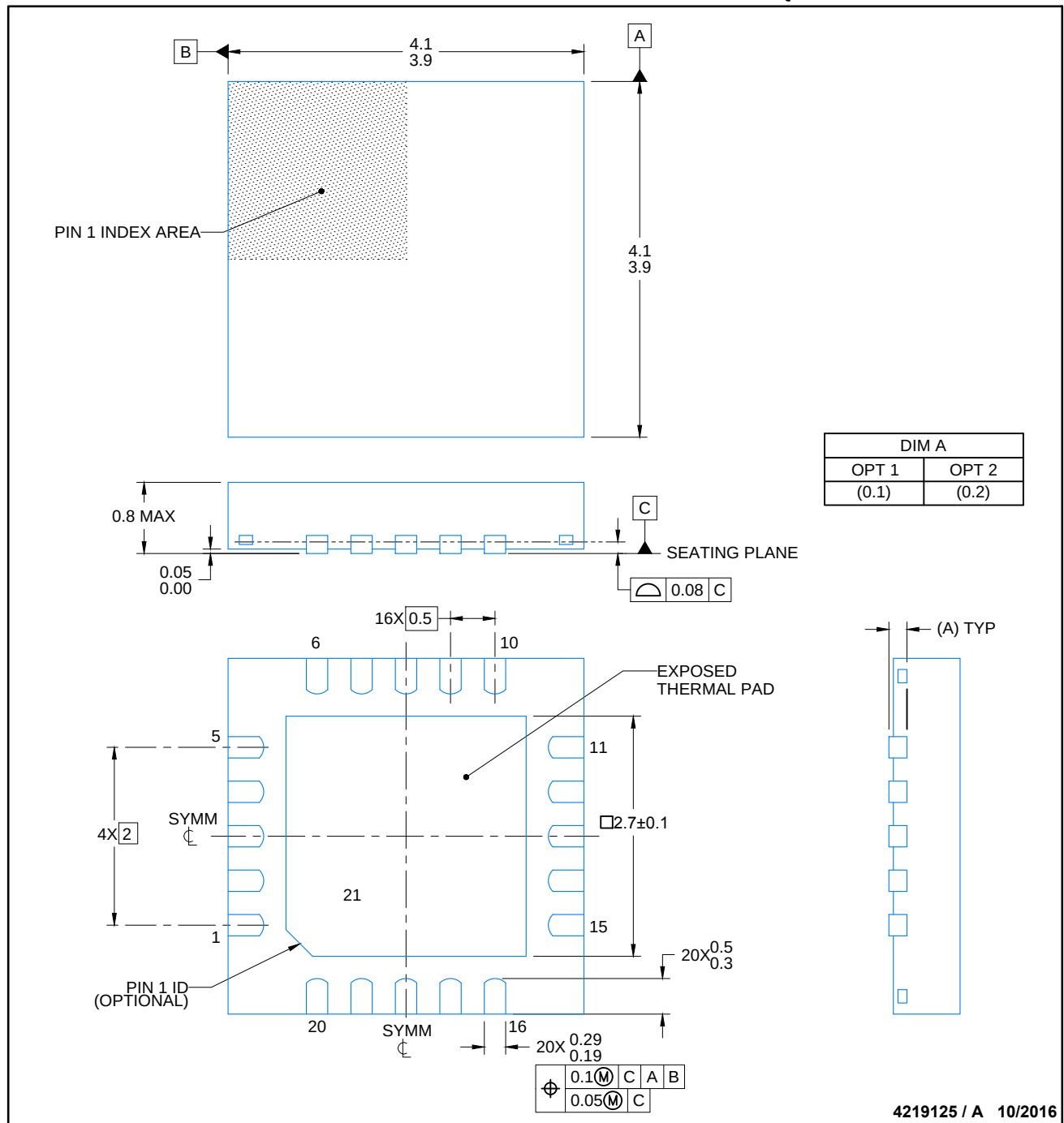
This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



DATA BOOK  
PACKAGE OUTLINE

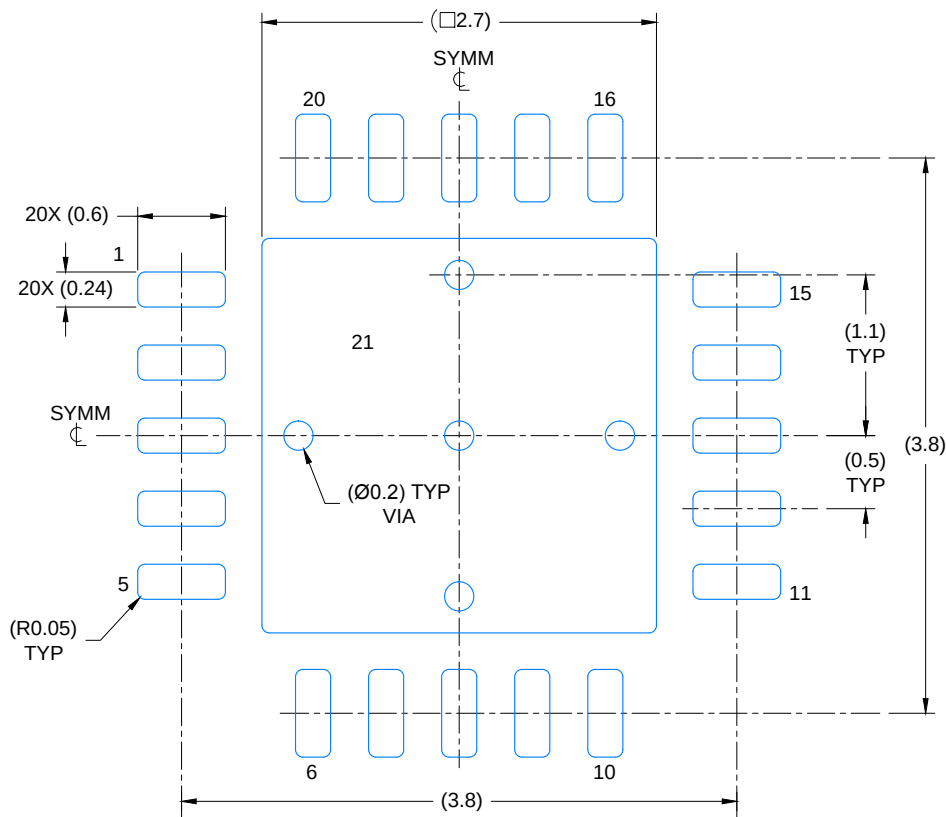
|                   |
|-------------------|
| LEADFRAME EXAMPLE |
| 4222370           |

|                                  |  |                     |  |                                                                                                                                                                                                    |           |                           |  |          |                |
|----------------------------------|--|---------------------|--|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|---------------------------|--|----------|----------------|
| DRAFTSMAN:<br>H. DENG            |  | DATE:<br>09/12/2016 |  |                                                                                                                                                                                                    |           | DIMENSIONS IN MILLIMETERS |  |          |                |
| DESIGNER:<br>H. DENG             |  | DATE:<br>09/12/2016 |  | <div> <b>TEXAS INSTRUMENTS</b><br/>SEMICONDUCTOR OPERATIONS</div> <div>CODE IDENTITY<br/>NUMBER<br/>01295</div> |           |                           |  |          |                |
| CHECKER:<br>V. PAKU & T. LEQUANG |  | DATE:<br>09/12/2016 |  |                                                                                                                                                                                                    |           |                           |  |          |                |
| ENGINEER:<br>T. TANG             |  | DATE:<br>09/12/2016 |  | ePOD, RTJ0020D / WQFN,<br>20 PIN, 0.5 MM PITCH                                                                                                                                                     |           |                           |  |          |                |
| APPROVED:<br>E. REY & D. CHIN    |  | DATE:<br>10/06/2016 |  |                                                                                                                                                                                                    |           |                           |  |          |                |
| RELEASED:<br>WDM                 |  | DATE:<br>10/24/2016 |  |                                                                                                                                                                                                    |           |                           |  |          |                |
| TEMPLATE INFO:<br>EDGE# 4218519  |  | DATE:<br>04/07/2016 |  | SCALE<br>15X                                                                                                                                                                                       | SIZE<br>A | 4219125                   |  | REV<br>A | PAGE<br>1 OF 5 |

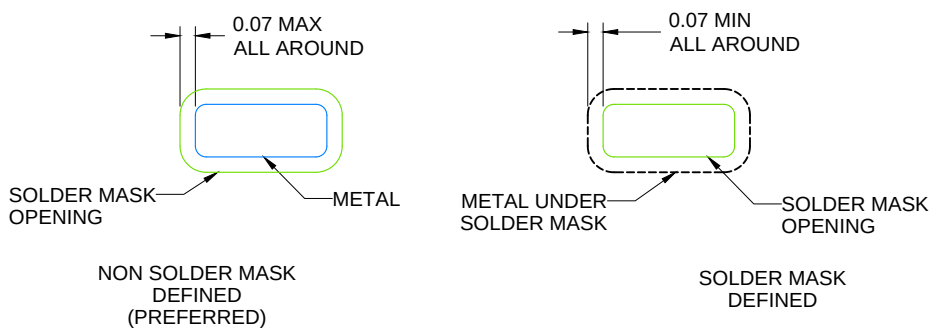


## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE  
SCALE: 20X

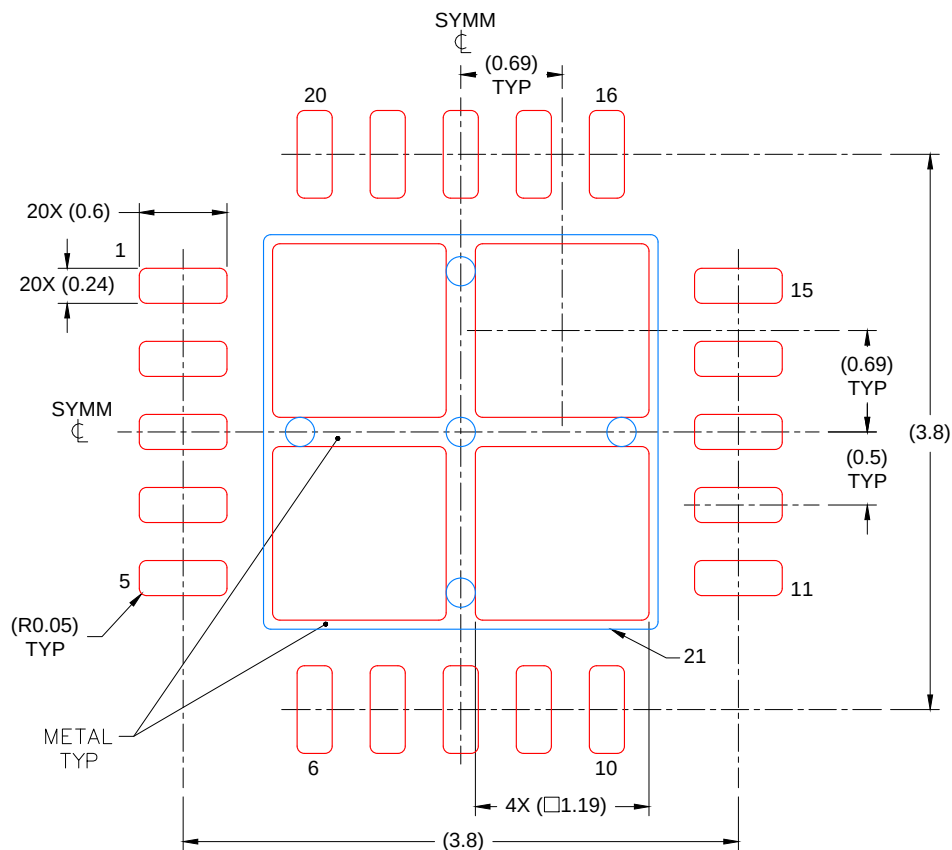


SOLDER MASK DETAILS

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NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slue271](http://www.ti.com/lit/slue271)).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD  
78% PRINTED COVERAGE BY AREA  
SCALE: 20X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

# REVISIONS

| REV | DESCRIPTION         | ECR     | DATE       | ENGINEER / DRAFTSMAN |
|-----|---------------------|---------|------------|----------------------|
| A   | RELEASE NEW DRAWING | 2160736 | 10/24/2016 | T. TANG / H. DENG    |

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